

1.8 V to 5.5 V, 80 μ A, 8 BIT, LOW POWER, SINGLE CHANNEL, DIGITAL-TO-ANALOG CONVERTER

FEATURES

- Qualified for Automotive Applications
- Relative Accuracy: 0.25 LSB INL
- Micro-Power Operation: 80 μ A at 1.8 V
- Power-Down: 0.5 μ A at 5 V, 0.1 μ A at 1.8 V
- Wide Power Supply: 1.8 V to 5.5 V
- Power-On Reset to Zero Scale
- Straight Binary Data Format
- Low Power Serial Interface With Schmitt-Triggered Inputs: Up to 50 MHz
- On-Chip Output Buffer Amplifier, Rail-to-Rail Operation
- SYNC Interrupt Facility
- Tiny 6-Pin SC70 Package

APPLICATIONS

- Portable, Battery-Powered instruments
- Process Control
- Digital Gain and Offset Adjustment
- Programmable Voltage and Current Sources

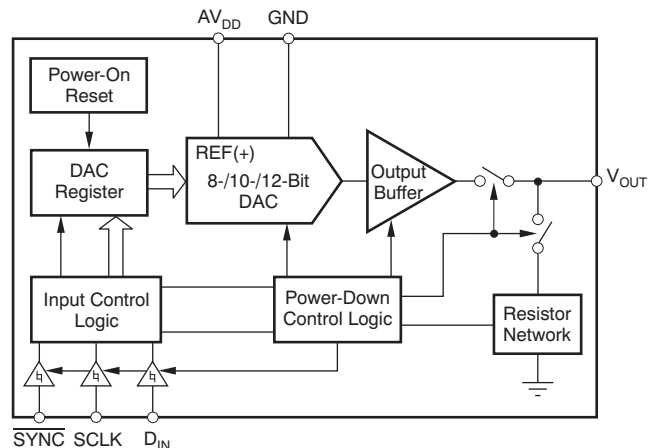
DESCRIPTION

The DAC5311 is an 8-bit, low-power, single-channel, voltage output, digital-to-analog converters (DAC). It is monotonic by design and provides excellent linearity and minimizes undesired code-to-code transient voltages while offering an easy upgrade path within a pin-compatible family. The device uses a versatile, 3-wire serial interface that operates at clock rates of up to 50 MHz and is compatible with standard SPI™, QSPI™, MICROWIRE™, and digital signal processor (DSP) interfaces.

DAC5311 uses an external power supply as a reference voltage to set the output range. The devices incorporate a power-on reset (POR) circuit that ensures the DAC output powers up at 0 V and remains there until a valid write to the device occurs. It contains a power-down feature, accessed over the serial interface, that reduces current consumption of the device to 0.1 μ A at 1.8 V in power-down mode. The low power consumption of this part in normal operation makes it ideally suited for portable battery-operated equipment. The power consumption is 0.55 mW at 5 V, reducing to 2.5 μ W in power-down mode.

DAC5311 is pin-compatible with the DAC8311 and DAC8411, offering an easy upgrade path from 8-bit resolution to 14- and 16-bit resolution. The device is available in a small 6-pin SC70 package. This package offers a flexible solution over the automotive temperature range of -40°C to 85°C .

RELATED DEVICES	16-BIT	14-BIT	12-BIT	10-BIT	8-BIT
Pin and Function Compatible	DAC8411	DAC8311	DAC7311	DAC6311	DAC5311



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION⁽¹⁾

T _A	MAXIMUM RELATIVE ACCURACY (LSB)	MAXIMUM DIFFERENTIAL NONLINEARITY (LSB)	PACKAGE ⁽²⁾		ORDERABLE PART NUMBER	PACKAGE MARKING
			SC70-6 – DCK	Reel of 3000		
–40°C to 85°C	±0.25	±0.25	SC70-6 – DCK	Reel of 3000	DAC5311IDCKRQ1	OCZ

(1) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

(2) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

AV _{DD} to GND	–0.3 V to 6 V
Digital input voltage to GND	–0.3 V to AV _{DD} +0.3 V
AV _{OUT} to GND	–0.3 V to AV _{DD} +0.3 V
Operating temperature range	–40°C to 85°C
Storage temperature range	–65°C to 150°C
Junction temperature (T _J max)	150°C
Power dissipation	(T _J max – T _A)/θ _{JA} W
θ _{JA} thermal impedance	250°C/W

(1) Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

 At $V_{DD} = 1.8\text{ V}$ to 5.5 V , $R_L = 2\text{ k}\Omega$ to GND, $C_L = 200\text{ pF}$ to GND (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC PERFORMANCE⁽¹⁾					
Resolution		8			Bits
Relative accuracy	Measured by the line passing through codes 3 and 252		± 0.01	± 0.25	LSB
Differential nonlinearity			± 0.01	± 0.25	LSB
Offset error	Measured by the line passing through two codes ⁽²⁾		± 0.05	± 4	mV
Offset error drift			3		$\mu\text{V}/^\circ\text{C}$
Zero code error	All zeros loaded to the DAC register		0.2		mV
Full-scale error	All ones loaded to DAC register		0.04	0.2	% of FSR
Gain error			0.05	± 0.15	% of FSR
Gain temperature coefficient	$V_{DD} = 5\text{ V}$		± 0.5		ppm of FSR/ $^\circ\text{C}$
	$V_{DD} = 1.8\text{ V}$		± 1.5		
OUTPUT CHARACTERISTICS⁽³⁾					
Output voltage range		0		V_{DD}	V
Output voltage settling time	$R_L = 2\text{ k}\Omega$, $C_L = 200\text{ pF}$, $V_{DD} = 5\text{ V}$, 1/4 scale to 3/4 scale		6	10	μs
	$R_L = 2\text{ M}\Omega$, $C_L = 470\text{ pF}$		12		μs
Slew rate			0.7		$\text{V}/\mu\text{s}$
Capacitive load stability	$R_L = \infty$		470		pF
	$R_L = 2\text{ k}\Omega$		1000		pF
Code change glitch impulse	1-LSB change around major carry		0.5		nV-s
Digital feed through			0.5		nV-s
Power-on glitch impulse	$R_L = 2\text{ k}\Omega$, $C_L = 200\text{ pF}$, $V_{DD} = 5\text{ V}$		17		mV
DC output impedance			0.5		Ω
Short-circuit current	$V_{DD} = 5\text{ V}$		50		mA
	$V_{DD} = 3\text{ V}$		20		mA
Power-up time	Coming out of power-down mode		50		μs
AC PERFORMANCE					
SNR			81		dB
THD	$T_A = 25^\circ\text{C}$, BW = 20 kHz, 12-bit level, $V_{DD} = 5\text{ V}$, $f_{OUT} = 1\text{ kHz}$, 1st 19 harmonics removed for SNR calculation		-65		dB
SFDR			65		dB
SINAD			65		dB
DAC output noise density ⁽⁴⁾	$T_A = 25^\circ\text{C}$, at zero-scale input, $f_{OUT} = 1\text{ kHz}$, $V_{DD} = 5\text{ V}$		17		$\text{nV}/\sqrt{\text{Hz}}$
	$T_A = 25^\circ\text{C}$, at mid-code input, $f_{OUT} = 1\text{ kHz}$, $V_{DD} = 5\text{ V}$		110		$\text{nV}/\sqrt{\text{Hz}}$
DAC output noise ⁽⁵⁾	$T_A = 25^\circ\text{C}$, at mid-code input, 0.1 Hz to 10 Hz, $V_{DD} = 5\text{ V}$		3		μV_{PP}

- (1) Linearity calculated using a reduced code range of 3 to 252, output unloaded.
- (2) Straight line passing through codes 3 and 252, output unloaded.
- (3) Specified by design and characterization, not production tested.
- (4) For more details, see [Figure 16](#).
- (5) For more details, see [Figure 17](#).

ELECTRICAL CHARACTERISTICS (continued)

At $V_{DD} = 1.8\text{ V to }5.5\text{ V}$, $R_L = 2\text{ k}\Omega$ to GND, $C_L = 200\text{ pF}$ to GND (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
LOGIC INPUTS⁽⁶⁾						
Input current					±1	μA
V_{INL} , input low voltage		$AV_{DD} = 5\text{ V}$			0.8	V
		$AV_{DD} = 1.8\text{ V}$			0.5	V
V_{INH} , input high voltage		$AV_{DD} = 5\text{ V}$	1.8			V
		$AV_{DD} = 1.8\text{ V}$	1.1			V
Pin capacitance				1.5	3	pF
POWER REQUIREMENTS						
AV_{DD}			1.8		5.5	V
I_{DD}	Normal mode	$V_{INH} = AV_{DD}$ and $V_{INL} = \text{GND}$, at midscale code ⁽⁷⁾	$AV_{DD} = 3.6\text{ V to }5.5\text{ V}$	110	160	μA
			$AV_{DD} = 2.7\text{ V to }3.6\text{ V}$	95	150	
			$AV_{DD} = 1.8\text{ V to }2.7\text{ V}$	80	140	
	Power-down mode	$V_{INH} = AV_{DD}$ and $V_{INL} = \text{GND}$, at midscale code	$AV_{DD} = 3.6\text{ V to }5.5\text{ V}$	0.5	3.5	μA
			$AV_{DD} = 2.7\text{ V to }3.6\text{ V}$	0.4	3.0	
			$AV_{DD} = 1.8\text{ V to }2.7\text{ V}$	0.1	2.0	
Power dissipation	Normal mode	$V_{INH} = AV_{DD}$ and $V_{INL} = \text{GND}$, at midscale code	$AV_{DD} = 3.6\text{ V to }5.5\text{ V}$	0.55	0.88	mW
			$AV_{DD} = 2.7\text{ V to }3.6\text{ V}$	0.25	0.54	
			$AV_{DD} = 1.8\text{ V to }2.7\text{ V}$	0.14	0.38	
	Power-down mode	$V_{INH} = AV_{DD}$ and $V_{INL} = \text{GND}$, at midscale code	$AV_{DD} = 3.6\text{ V to }5.5\text{ V}$	2.50	19.2	μW
			$AV_{DD} = 2.7\text{ V to }3.6\text{ V}$	1.08	10.8	
			$AV_{DD} = 1.8\text{ V to }2.7\text{ V}$	0.72	8.1	
TEMPERATURE RANGE						
Specified performance range			-40		85	°C

(6) Specified by design and characterization, not production tested.

(7) For more details, see [Figure 9](#), [Figure 44](#), and [Figure 69](#).

PIN CONFIGURATION

DCK PACKAGE
SC70-6
(TOP VIEW)

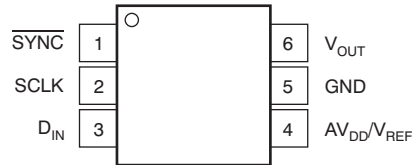
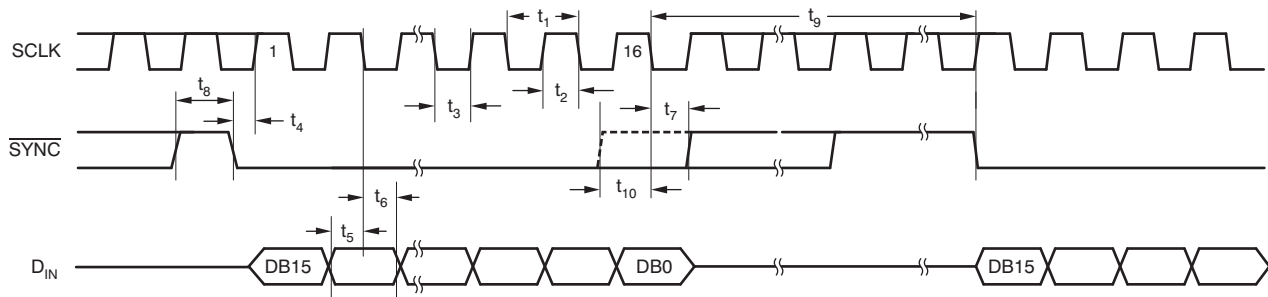


Table 1. PIN DESCRIPTION

PIN	NAME	DESCRIPTION
1	$\overline{\text{SYNC}}$	Level-triggered control input (active low). This is the frame synchronization signal for the input data. When $\overline{\text{SYNC}}$ goes low, it enables the input shift register and data are transferred in on the falling edges of the following clocks. The DAC is updated following 16th clock cycle, unless $\overline{\text{SYNC}}$ is taken high before this edge, in which case the rising edge of $\overline{\text{SYNC}}$ acts as an interrupt and the write sequence is ignored by the DAC5311. See the <i>SYNC Interrupt</i> section for more details.
2	SCLK	Serial clock input. Data can be transferred at rates up to 50 MHz.
3	D _{IN}	Serial data input. Data is clocked into the 16-bit input shift register on the falling edge of the serial clock input.
4	AV _{DD} /V _{REF}	Power supply input, 1.8 V to 5.5 V.
5	GND	Ground reference point for all circuitry on the part.
6	V _{OUT}	Analog output voltage from DAC. The output amplifier has rail-to-rail operation.

SERIAL WRITE OPERATION



TIMING REQUIREMENTS⁽¹⁾

All specifications at –40°C to 85°C, AV_{DD} = 1.8 V to 5.5 V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t ₁ ⁽²⁾ SCLK cycle time	AV _{DD} = 1.8 V to 3.6 V	50			ns
	AV _{DD} = 3.6 V to 5.5 V	20			
t ₂ SCLK high time	AV _{DD} = 1.8 V to 3.6 V	25			ns
	AV _{DD} = 3.6 V to 5.5 V	10			
t ₃ SCLK low time	AV _{DD} = 1.8 V to 3.6 V	25			ns
	AV _{DD} = 3.6 V to 5.5 V	10			
t ₄ $\overline{\text{SYNC}}$ to SCLK rising edge setup time	AV _{DD} = 1.8 V to 3.6 V	0			ns
	AV _{DD} = 3.6 V to 5.5 V	0			
t ₅ Data setup time	AV _{DD} = 1.8 V to 3.6 V	5			ns
	AV _{DD} = 3.6 V to 5.5 V	5			
t ₆ Data hold time	AV _{DD} = 1.8 V to 3.6 V	4.5			ns
	AV _{DD} = 3.6 V to 5.5 V	4.5			
t ₇ SCLK falling edge to $\overline{\text{SYNC}}$ rising edge	AV _{DD} = 1.8 V to 3.6 V	0			ns
	AV _{DD} = 3.6 V to 5.5 V	0			
t ₈ Minimum $\overline{\text{SYNC}}$ high time	AV _{DD} = 1.8 V to 3.6 V	50			ns
	AV _{DD} = 3.6 V to 5.5 V	20			
t ₉ 16th SCLK falling edge to $\overline{\text{SYNC}}$ falling edge	AV _{DD} = 1.8 V to 3.6 V	100			ns
	AV _{DD} = 3.6 V to 5.5 V	100			
t ₁₀ $\overline{\text{SYNC}}$ rising edge to 16th SCLK falling edge (for successful $\overline{\text{SYNC}}$ interrupt)	AV _{DD} = 1.8 V to 3.6 V	15			ns
	AV _{DD} = 3.6 V to 5.5 V	15			

(1) All input signals are specified with t_R = t_F = 3 ns (10% to 90% of AV_{DD}) and timed from a voltage level of (V_{IL} + V_{IH})/2.

(2) Maximum SCLK frequency is 50 MHz at AV_{DD} = 3.6 V to 5.5 V and 20 MHz at AV_{DD} = 1.8 V to 3.6 V.

TYPICAL CHARACTERISTICS: $AV_{DD} = 5\text{ V}$

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 5\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

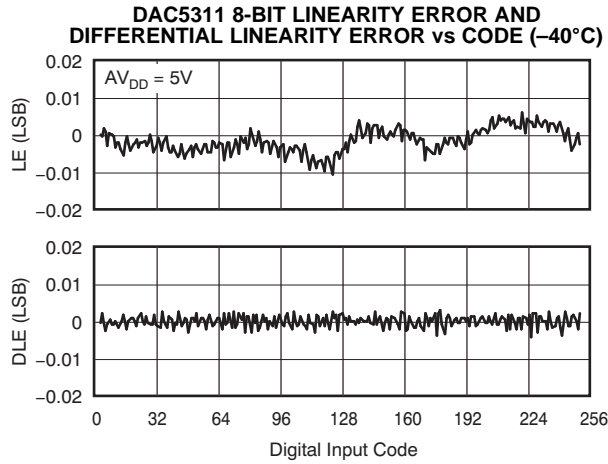


Figure 1.

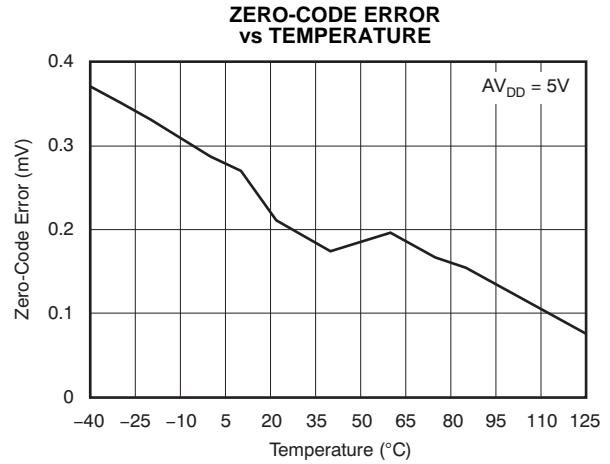


Figure 2.

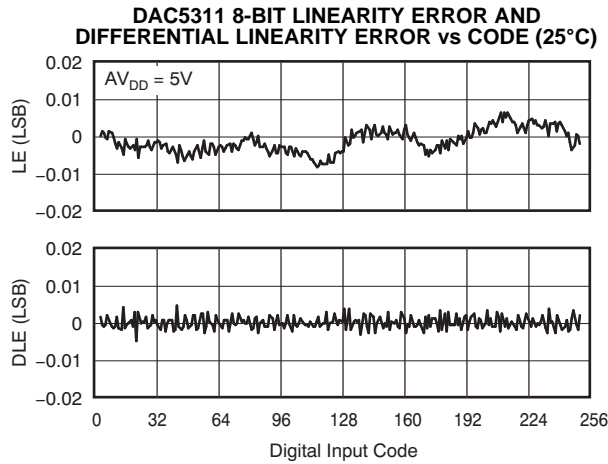


Figure 3.

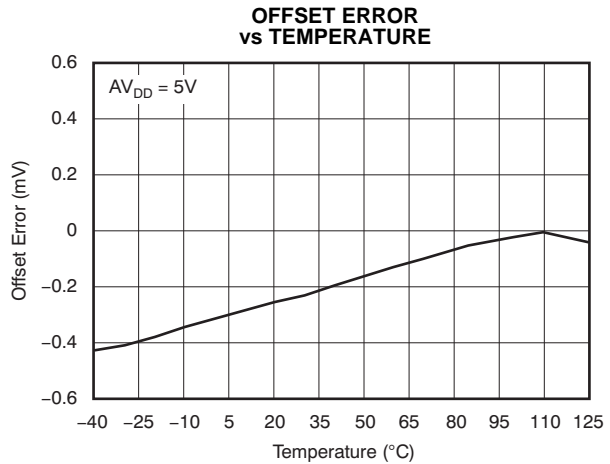


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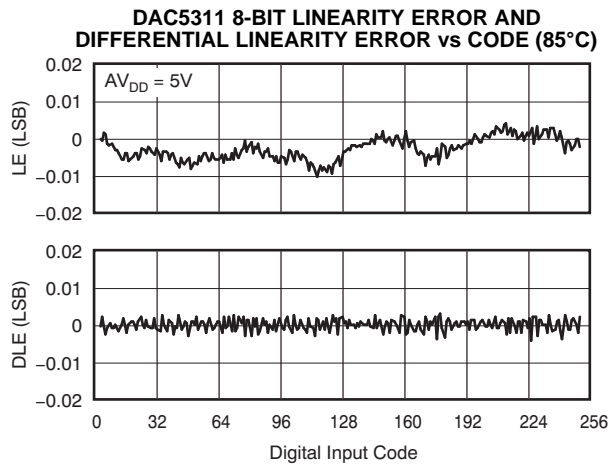


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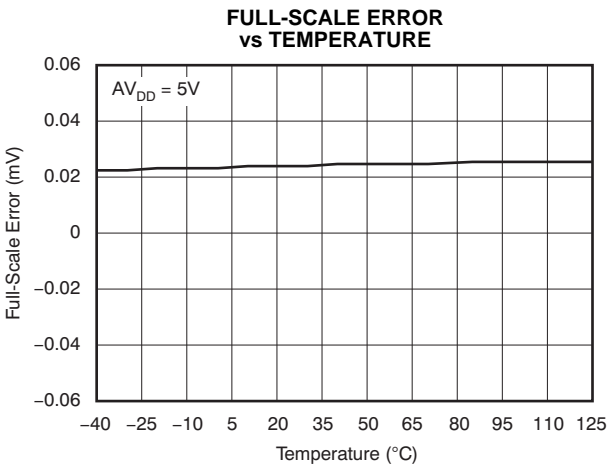
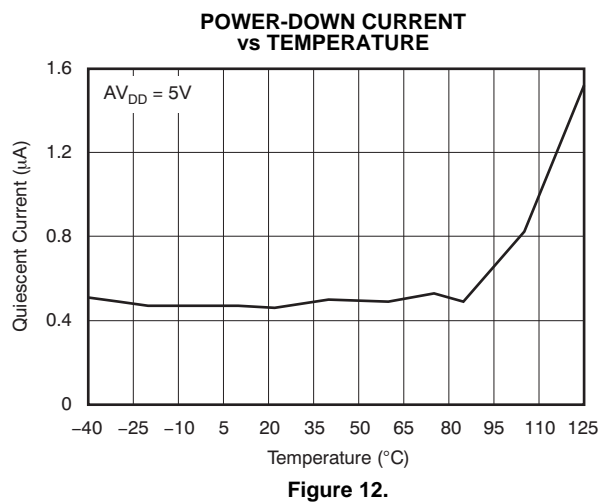
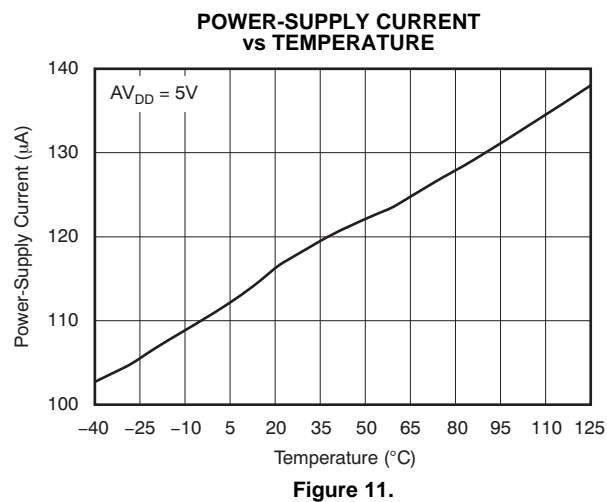
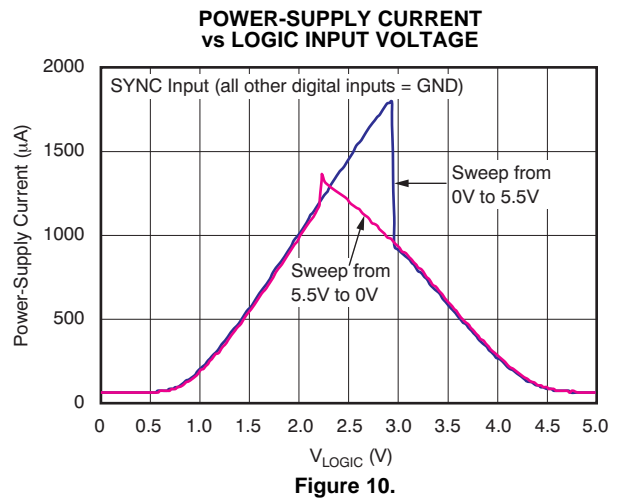
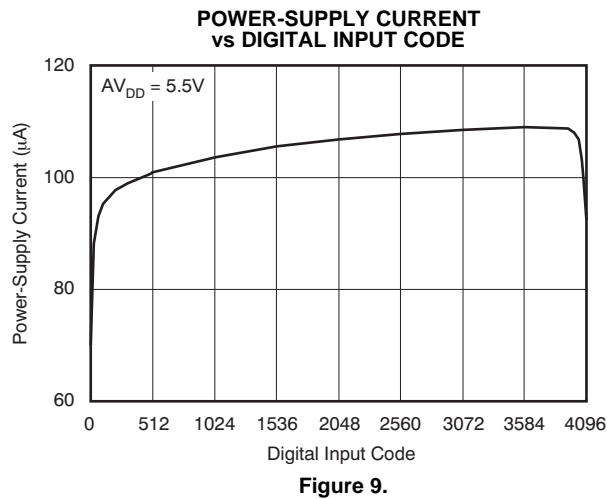
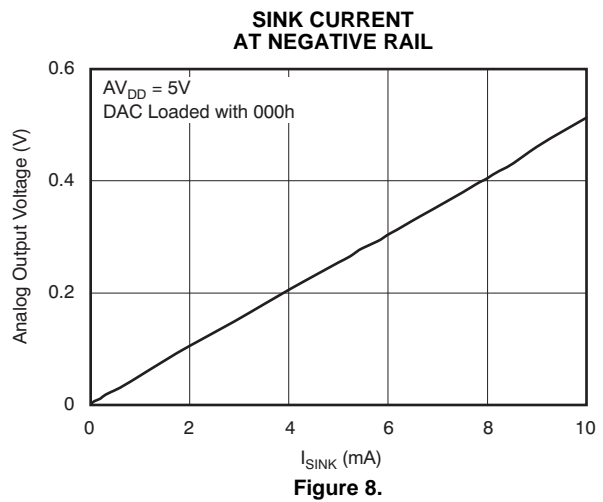
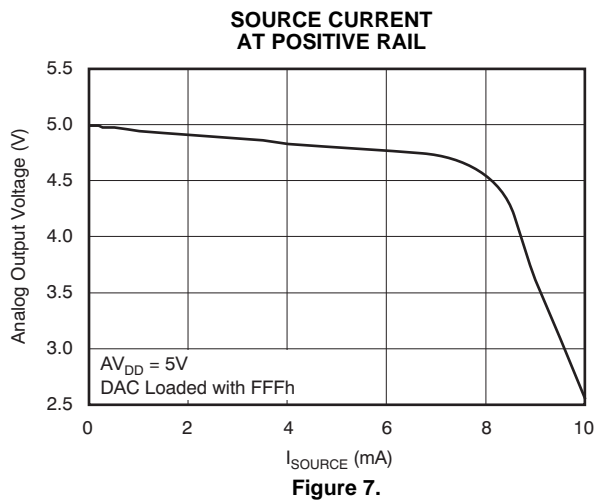


Figure 6.

TYPICAL CHARACTERISTICS: $AV_{DD} = 5\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 5\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)



TYPICAL CHARACTERISTICS: AV_{DD} = 5 V (continued)

At T_A = 25°C, AV_{DD} = 5 V, and DAC loaded with midscale code (unless otherwise noted)

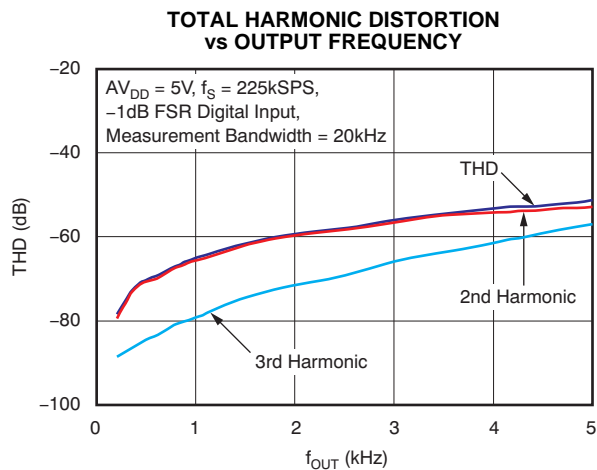


Figure 13.

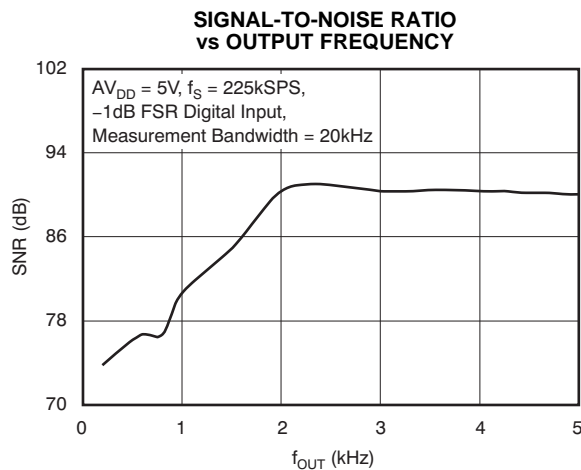


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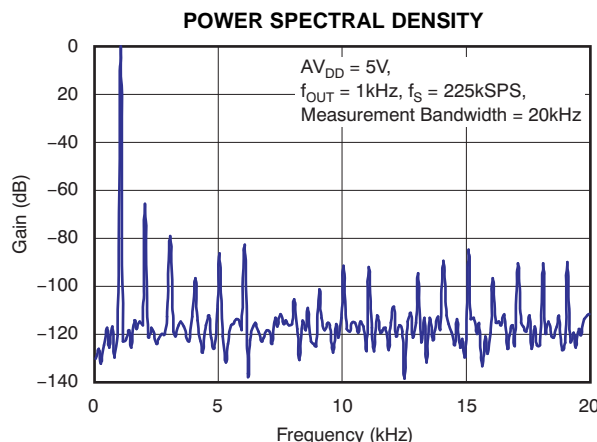


Figure 15.

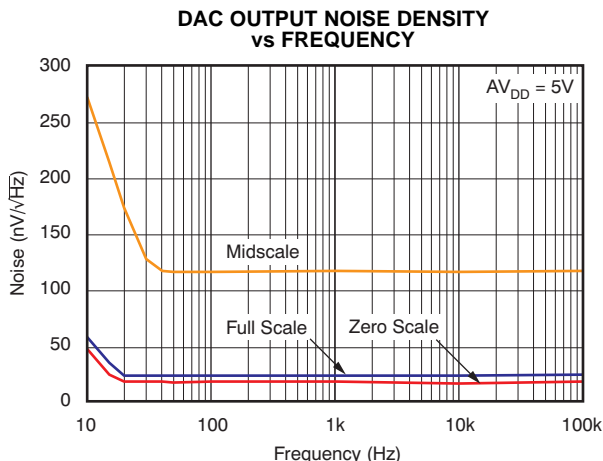


Figure 16.

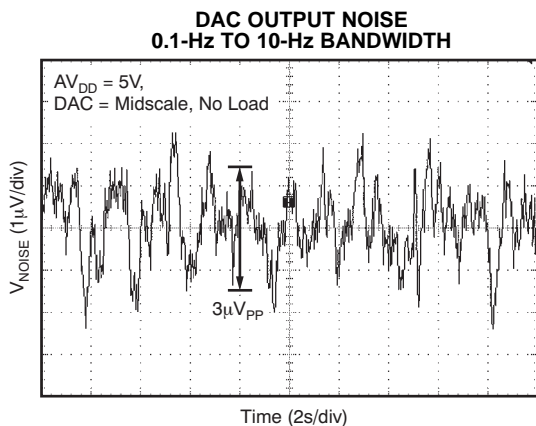


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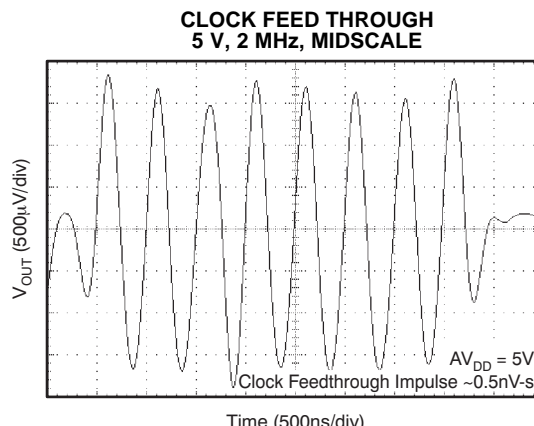


Figure 18.

TYPICAL CHARACTERISTICS: $V_{DD} = 5\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $V_{DD} = 5\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

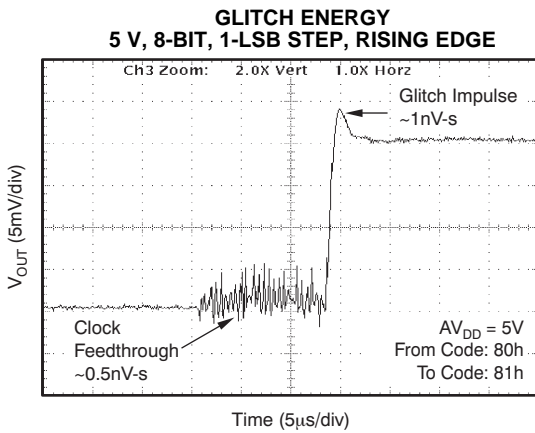


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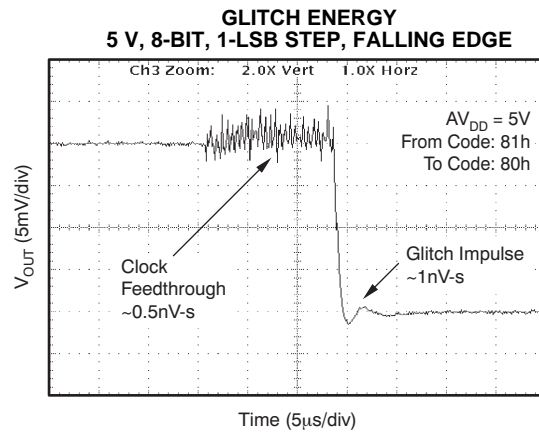


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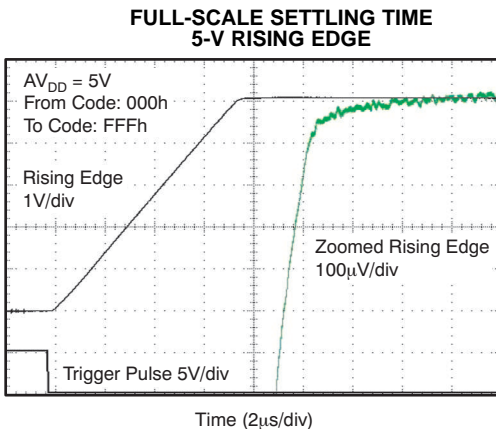


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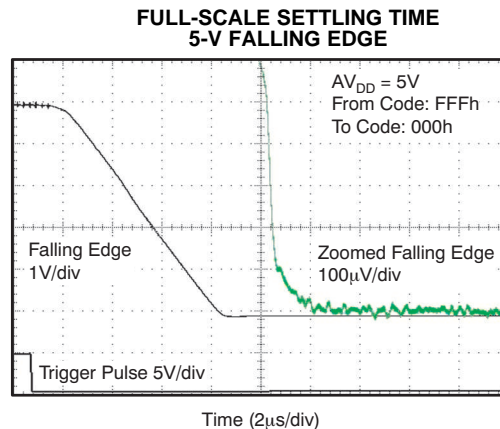


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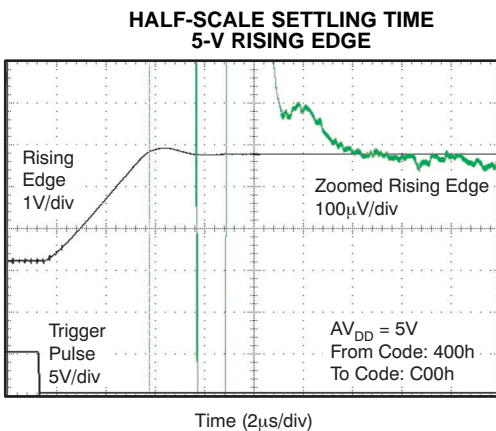


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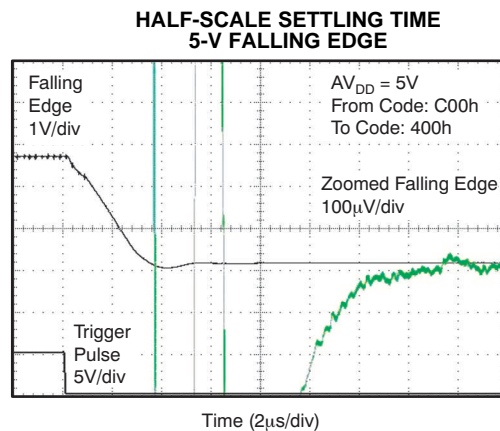


Figure 24.

TYPICAL CHARACTERISTICS: AV_{DD} = 5 V (continued)

At T_A = 25°C, AV_{DD} = 5 V, and DAC loaded with midscale code (unless otherwise noted)

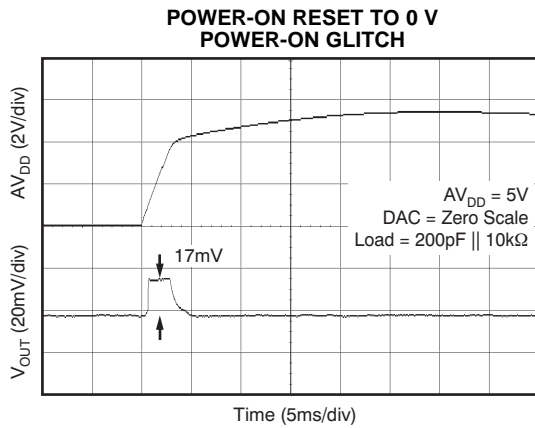


Figure 25.

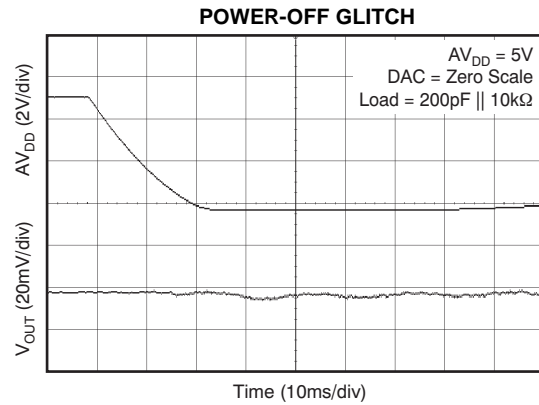


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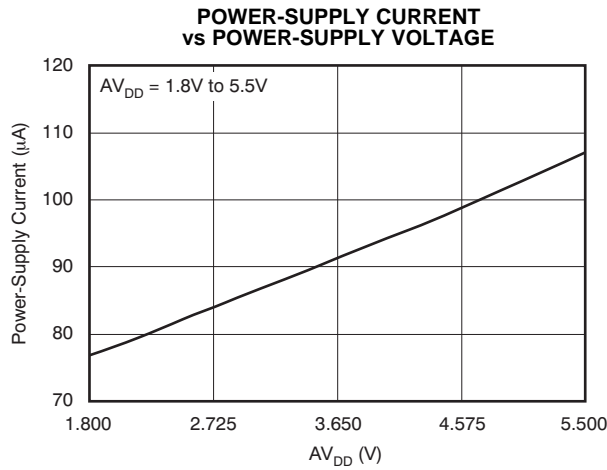


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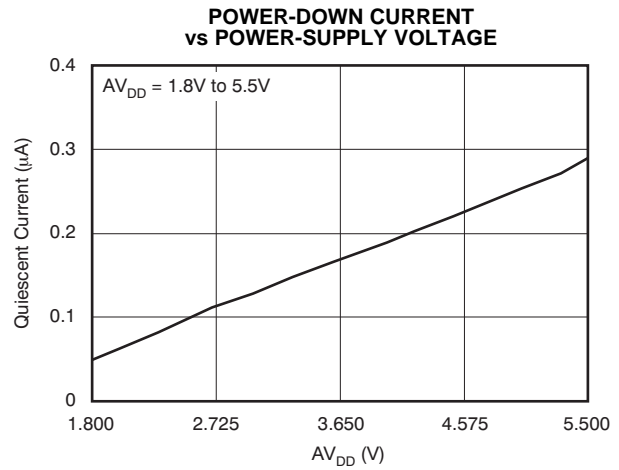


Figure 28.

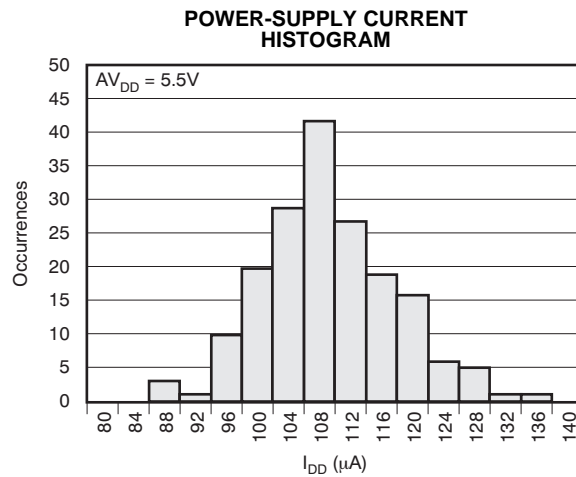


Figure 29.

TYPICAL CHARACTERISTICS: $V_{DD} = +3.6\text{ V}$

At $T_A = 25^\circ\text{C}$, $V_{DD} = +3.6\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

POWER-SUPPLY CURRENT vs TEMPERATURE

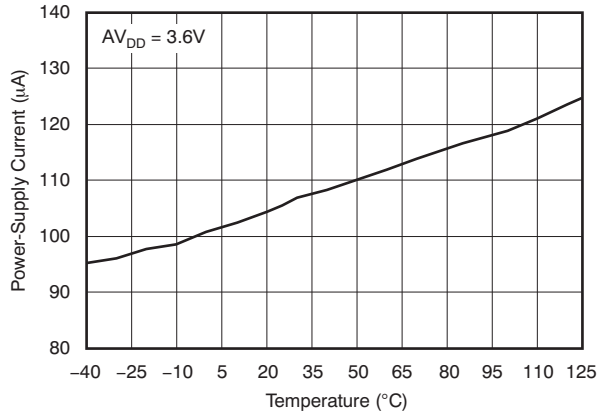


Figure 30.

POWER-DOWN CURRENT vs TEMPERATURE

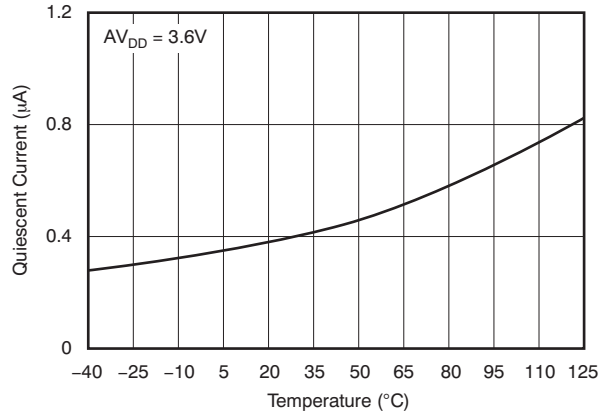


Figure 31.

POWER-SUPPLY CURRENT vs LOGIC INPUT VOLTAGE

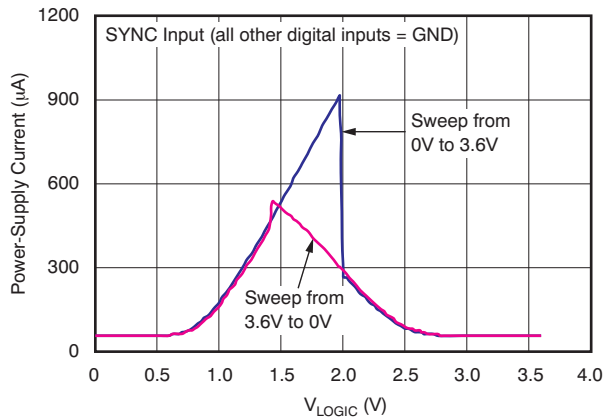


Figure 32.

POWER-SUPPLY CURRENT HISTOGRAM

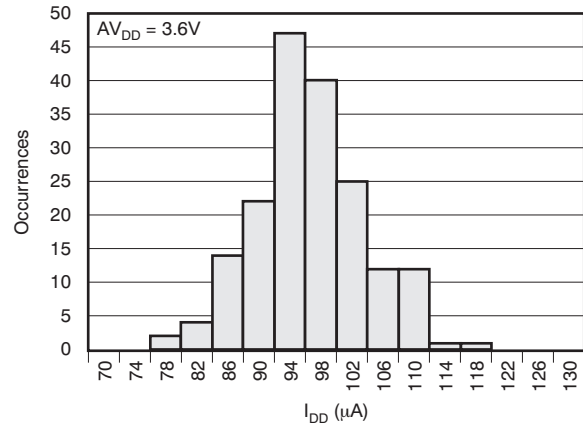


Figure 33.

SOURCE CURRENT AT POSITIVE RAIL

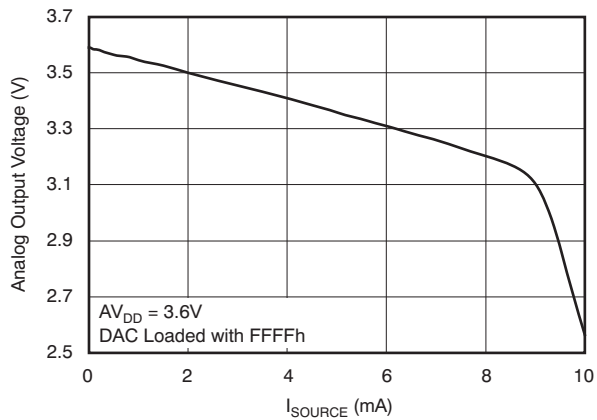


Figure 34.

SINK CURRENT AT NEGATIVE RAIL

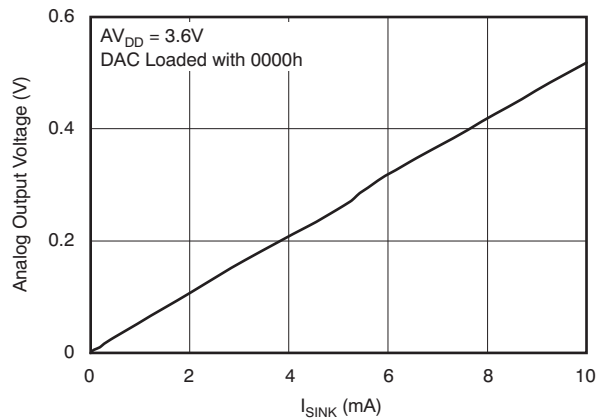


Figure 35.

TYPICAL CHARACTERISTICS: $AV_{DD} = 2.7\text{ V}$

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 2.7\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

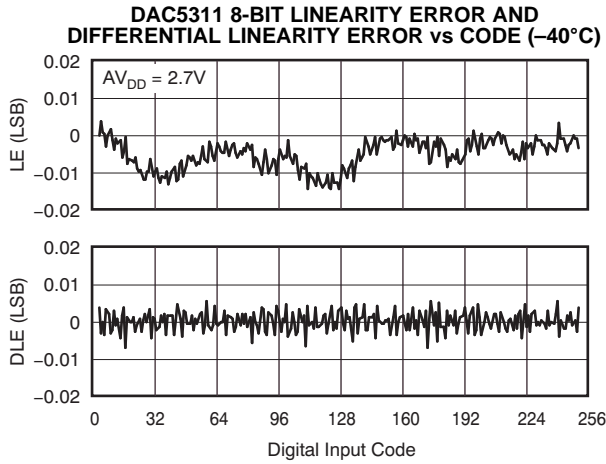


Figure 36.

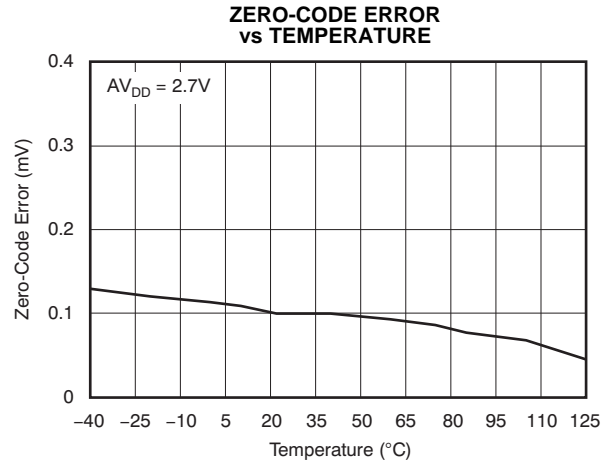


Figure 37.

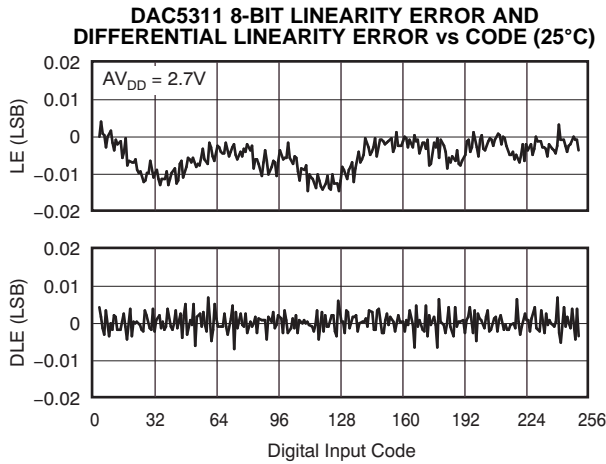


Figure 38.

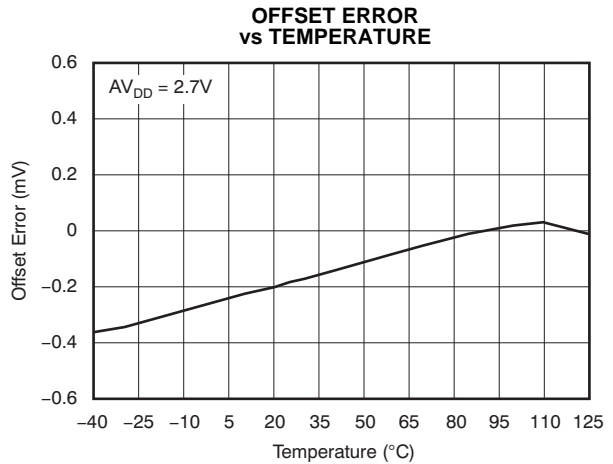


Figure 39.

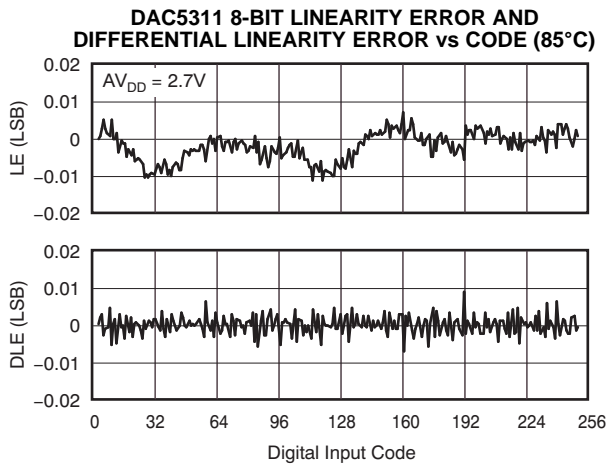


Figure 40.

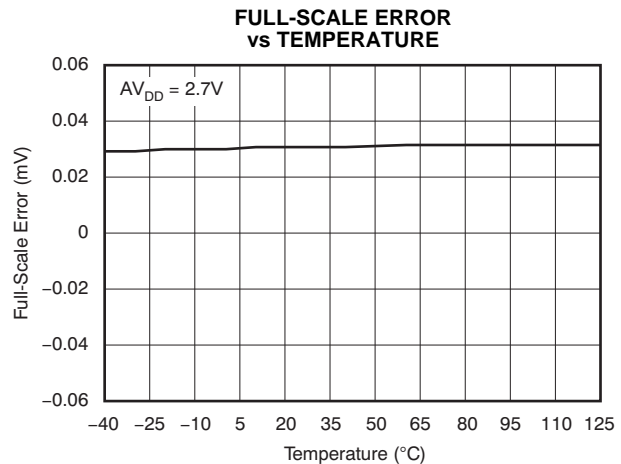
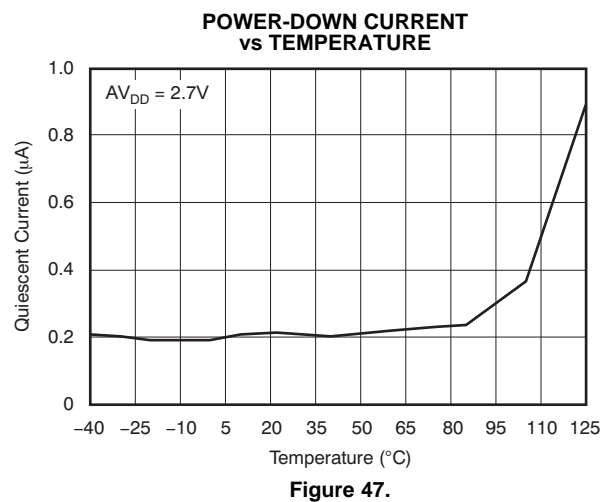
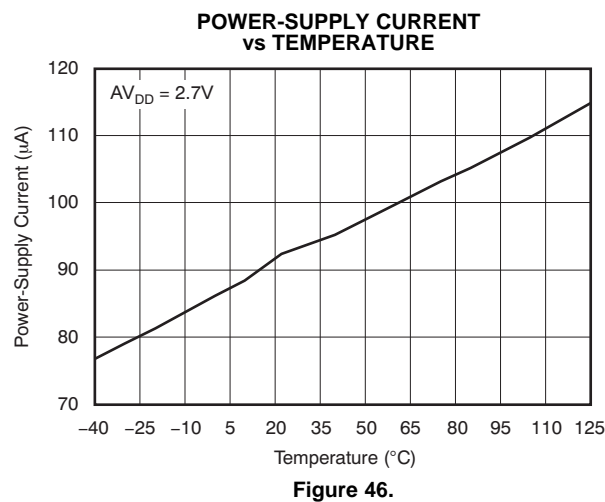
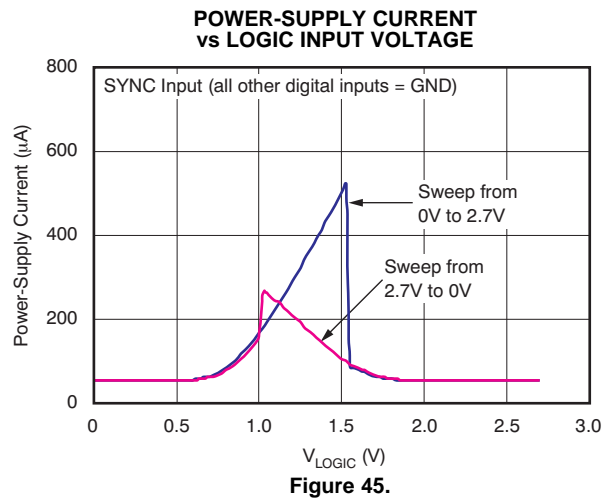
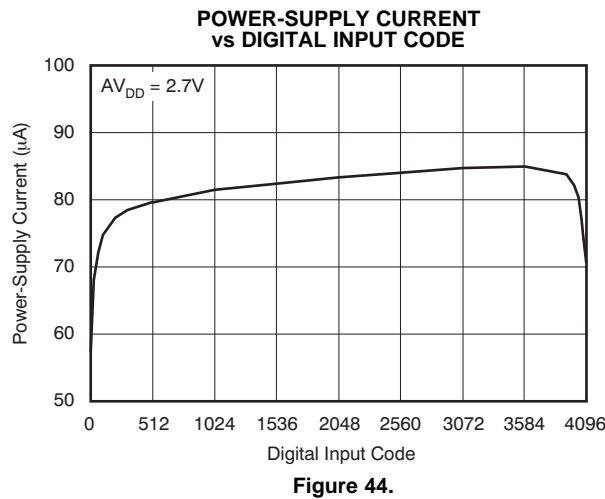
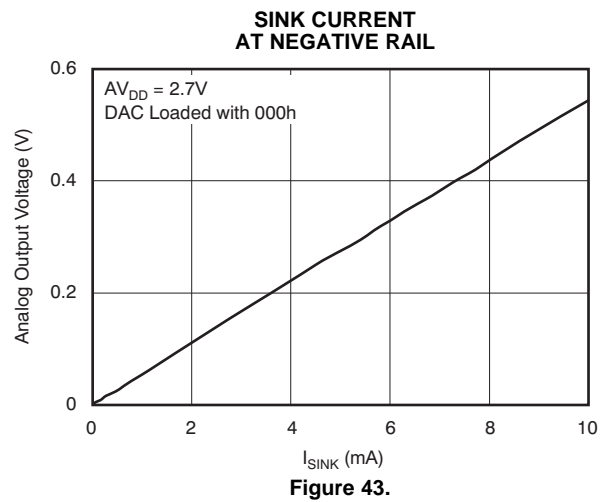
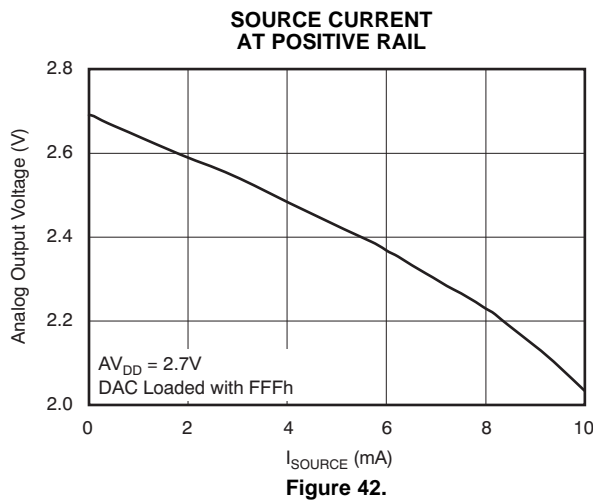


Figure 41.

TYPICAL CHARACTERISTICS: $AV_{DD} = 2.7\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 2.7\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)



TYPICAL CHARACTERISTICS: $AV_{DD} = 2.7\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 2.7\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

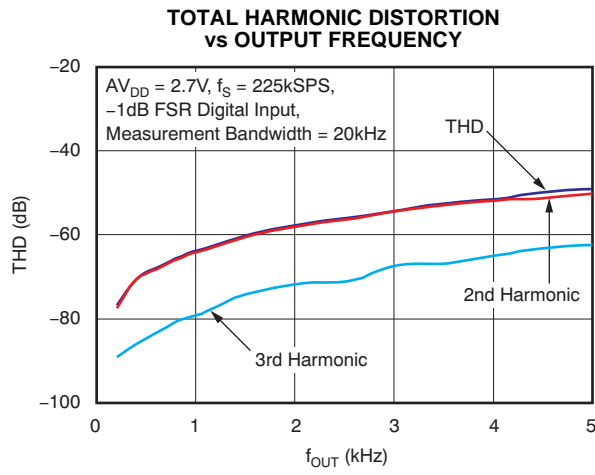


Figure 48.

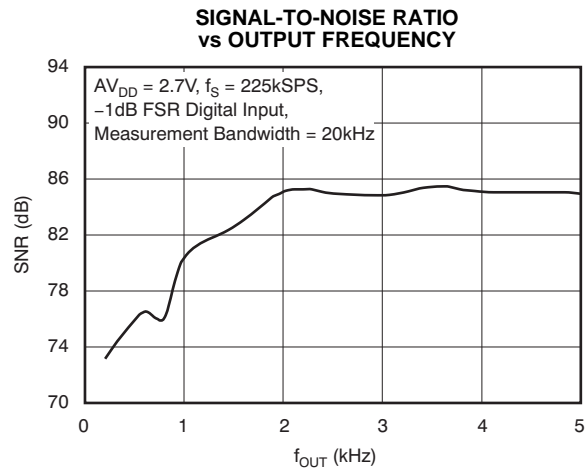


Figure 49.

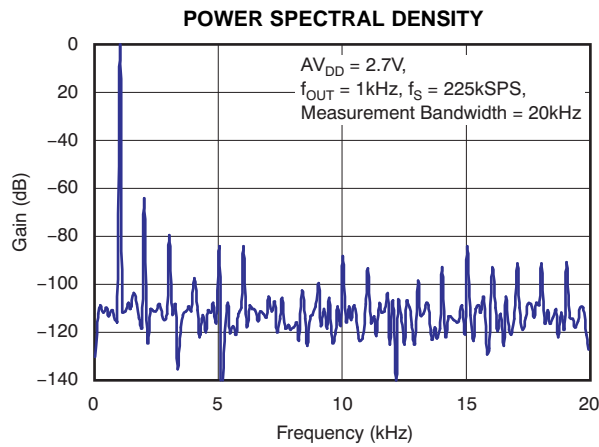


Figure 50.

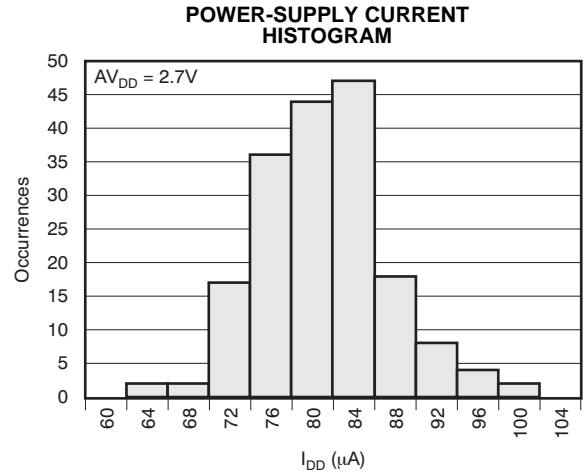


Figure 51.

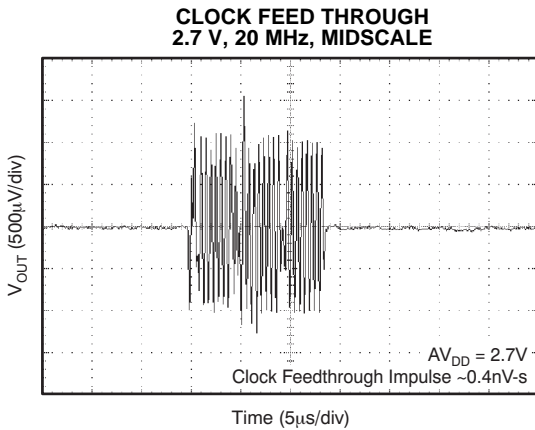


Figure 52.

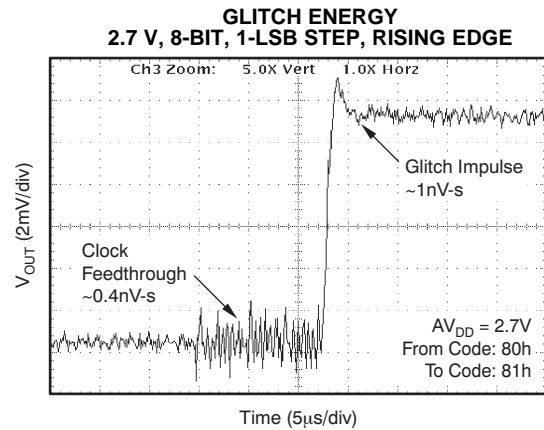


Figure 53.

TYPICAL CHARACTERISTICS: $A_{V_{DD}} = 2.7\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $A_{V_{DD}} = 2.7\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

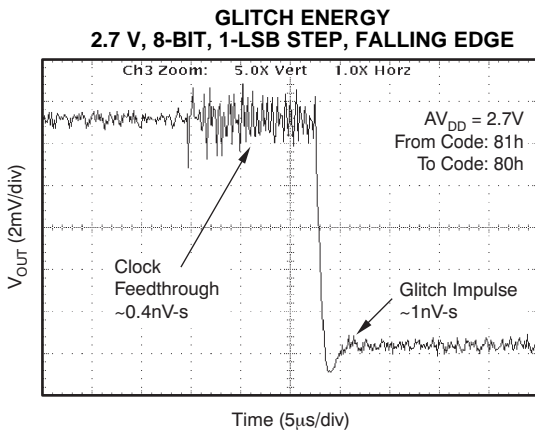


Figure 54.

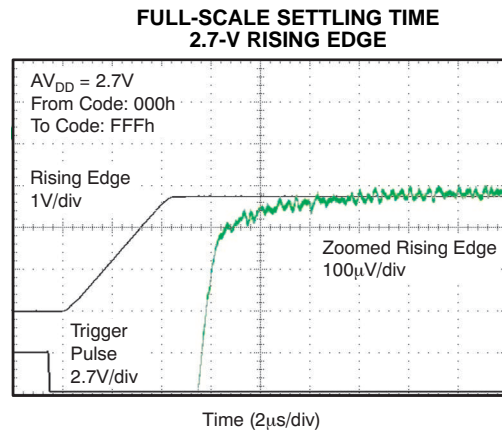


Figure 55.

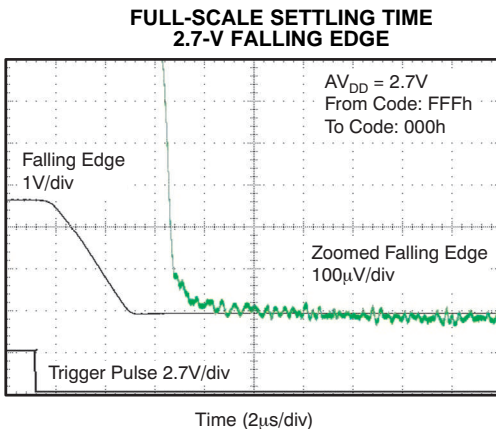


Figure 56.

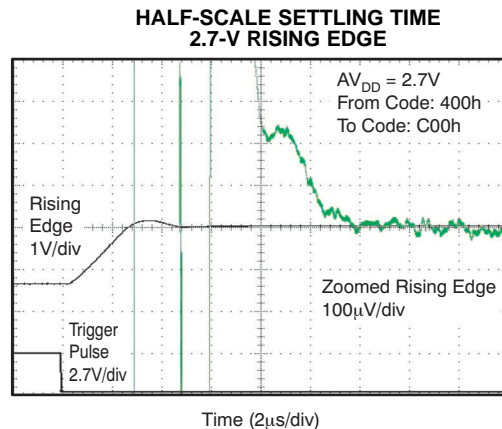


Figure 57.

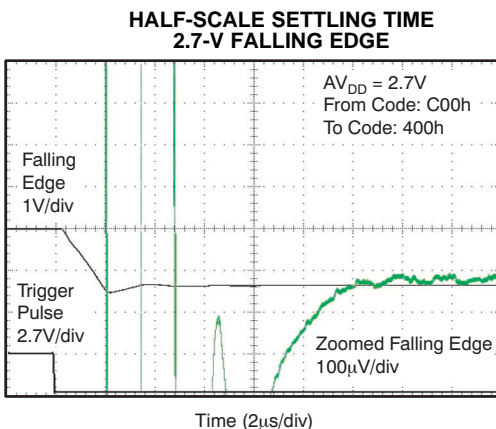


Figure 58.

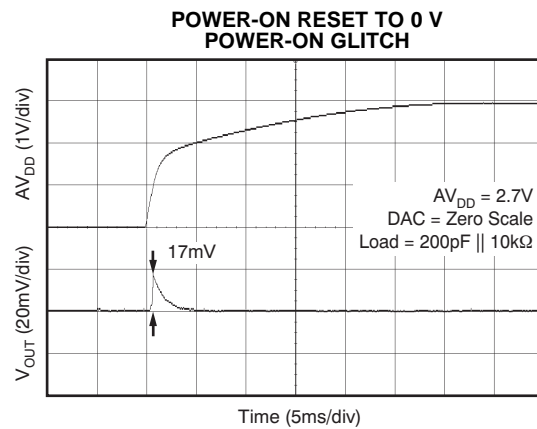


Figure 59.

TYPICAL CHARACTERISTICS: $AV_{DD} = 2.7\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 2.7\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

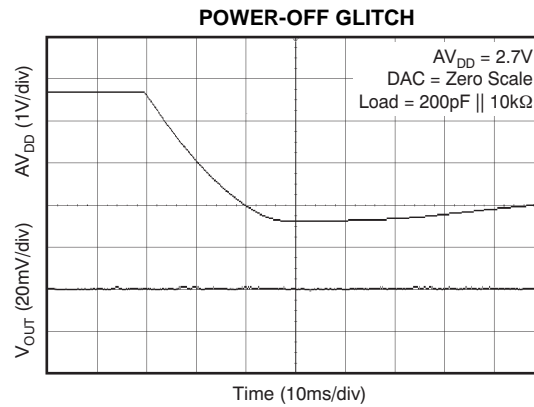


Figure 60.

TYPICAL CHARACTERISTICS: $AV_{DD} = 1.8\text{ V}$

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 1.8\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

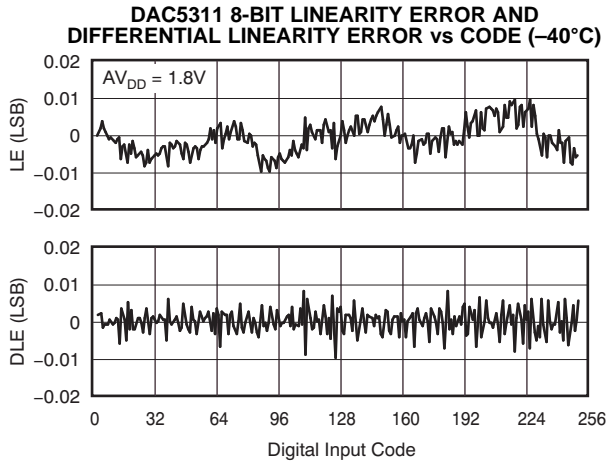


Figure 61.

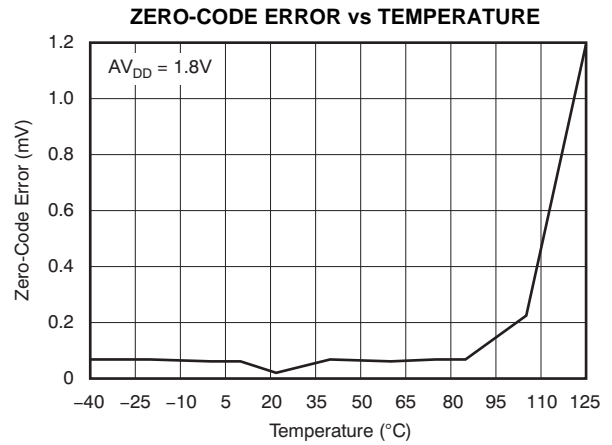


Figure 62.

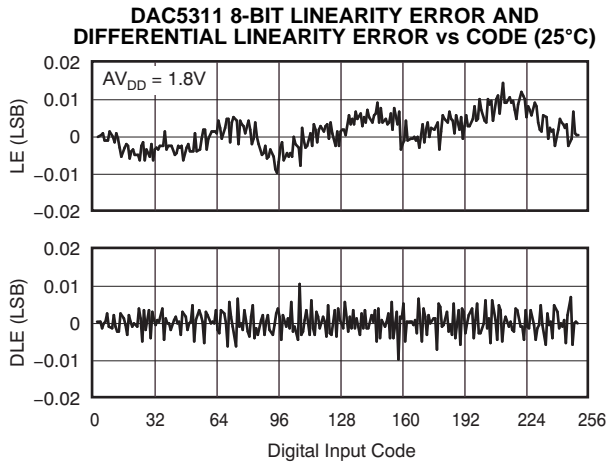


Figure 63.

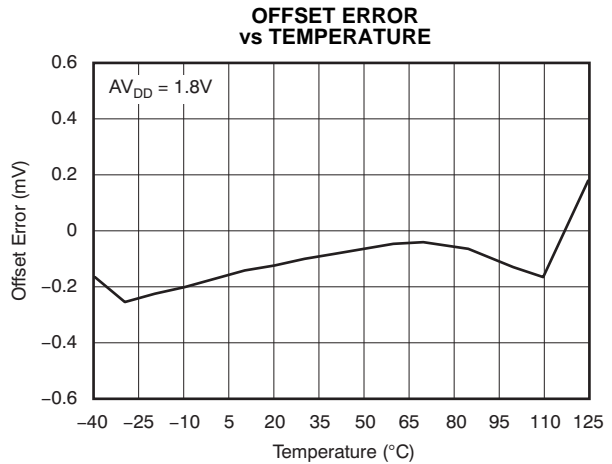


Figure 64.

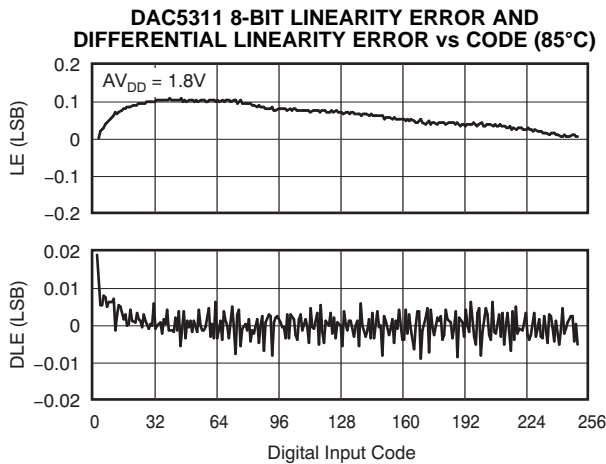


Figure 65.

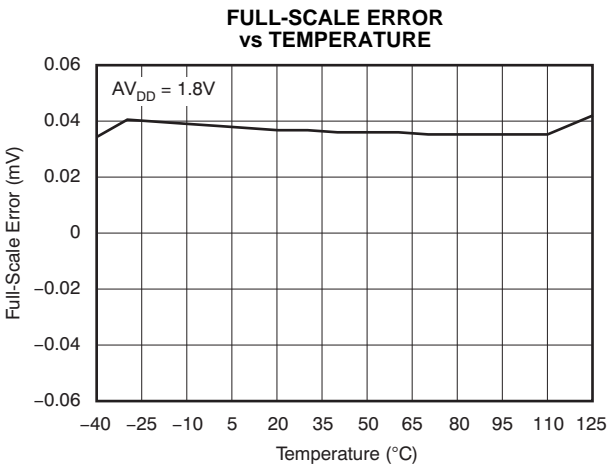
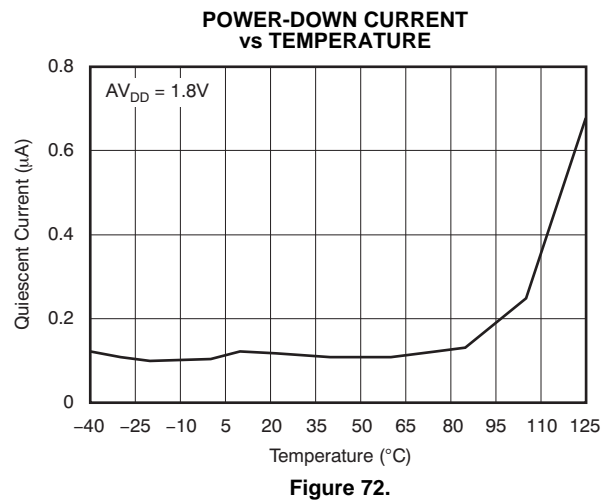
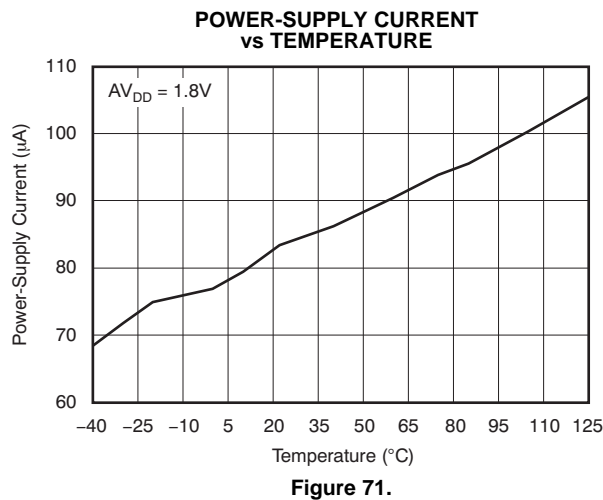
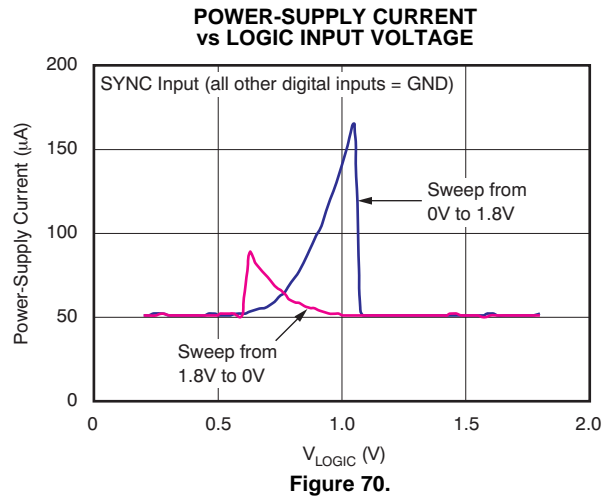
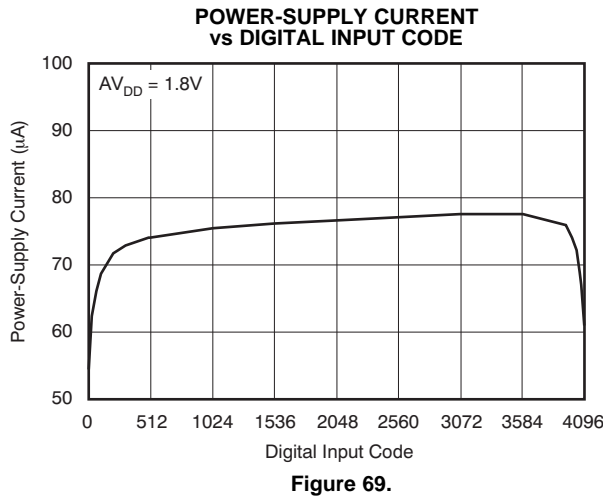
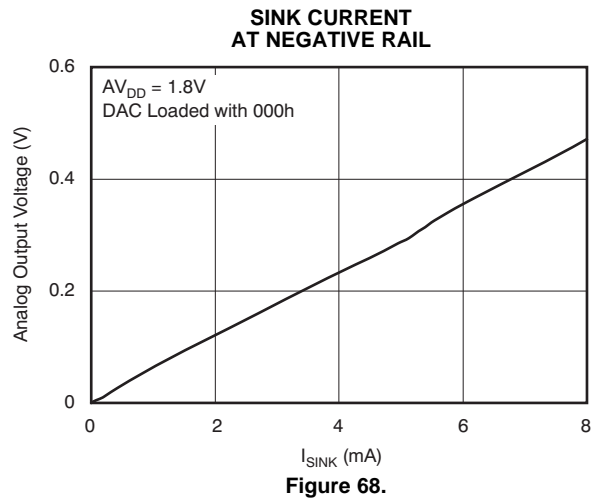
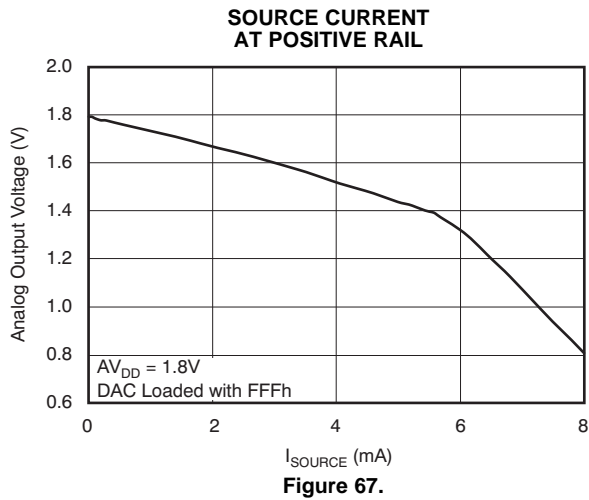


Figure 66.

TYPICAL CHARACTERISTICS: $AV_{DD} = 1.8\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 1.8\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)



TYPICAL CHARACTERISTICS: $AV_{DD} = 1.8\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 1.8\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

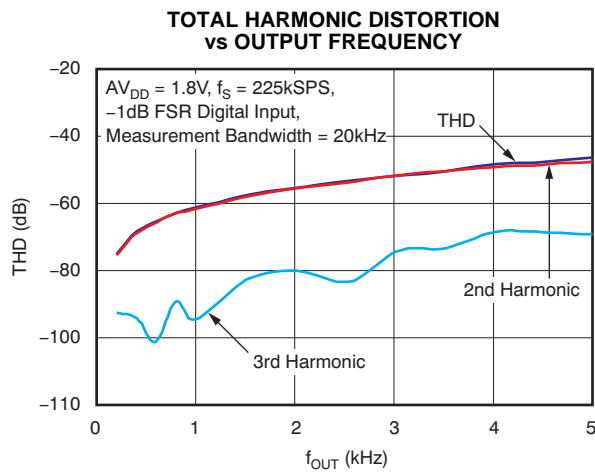


Figure 73.

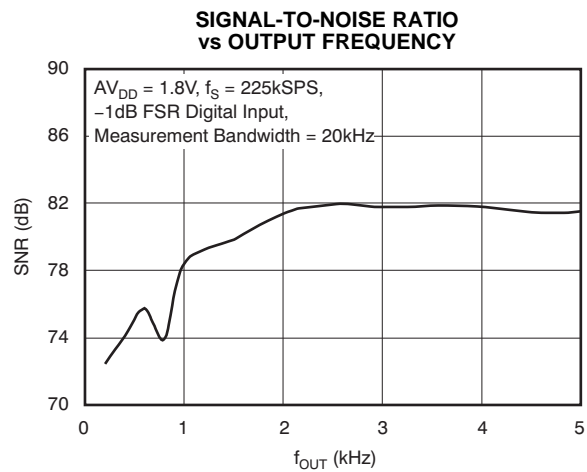


Figure 74.

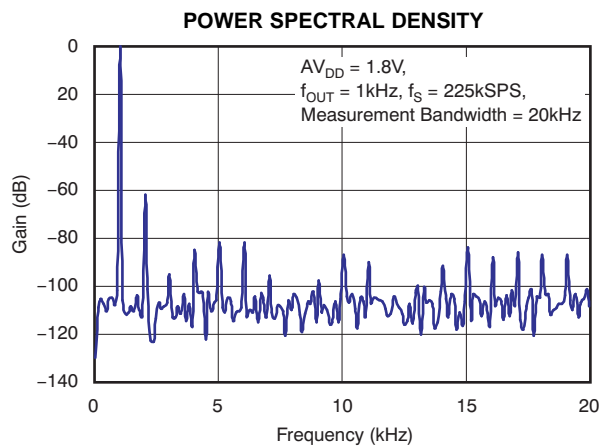


Figure 75.

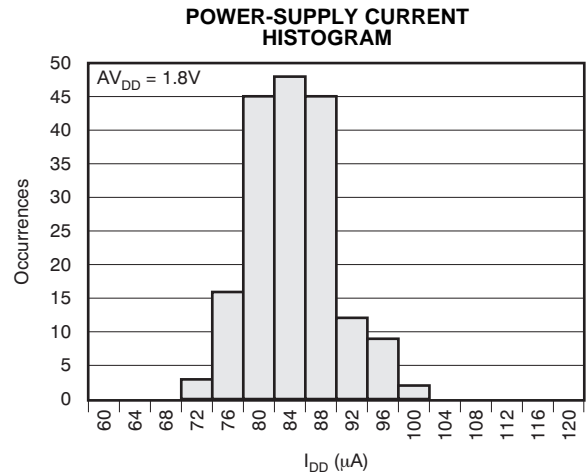


Figure 76.

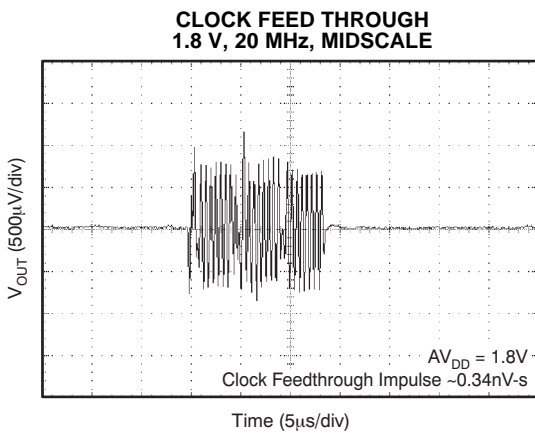


Figure 77.

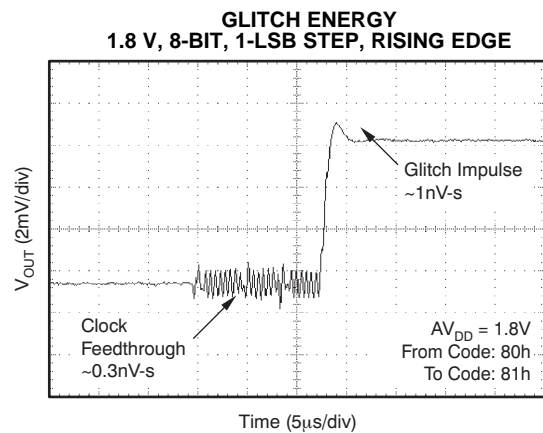


Figure 78.

TYPICAL CHARACTERISTICS: $AV_{DD} = 1.8\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 1.8\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

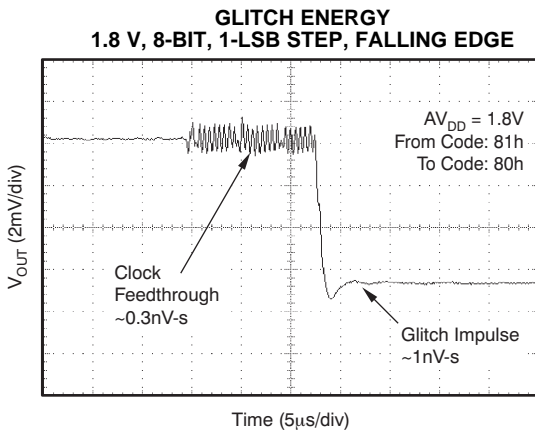


Figure 79.

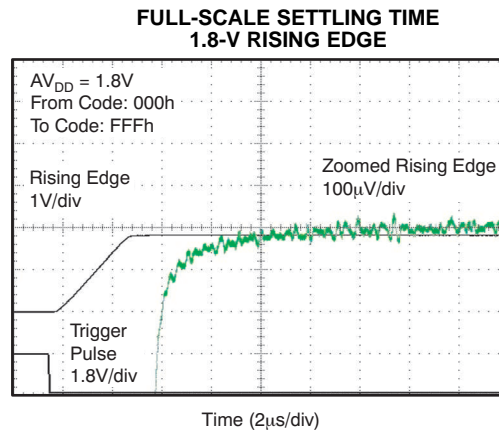


Figure 80.

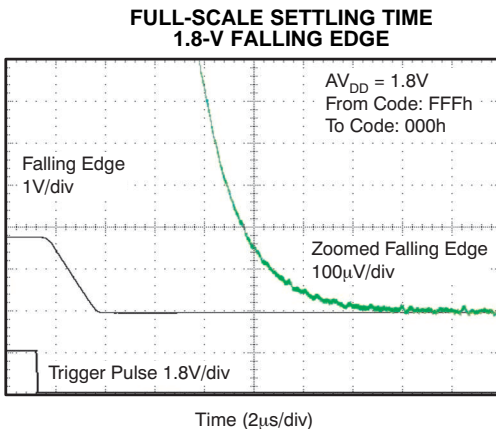


Figure 81.

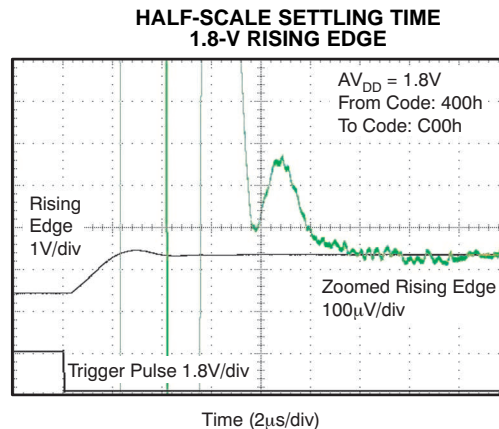


Figure 82.

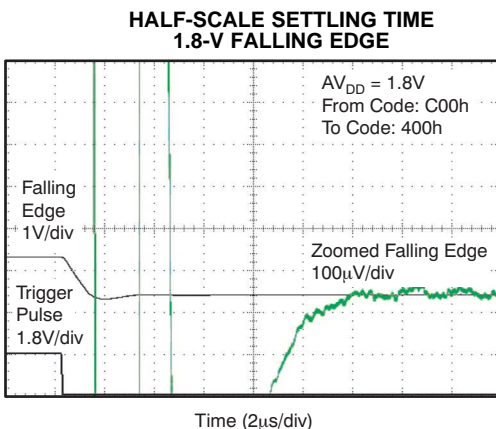


Figure 83.

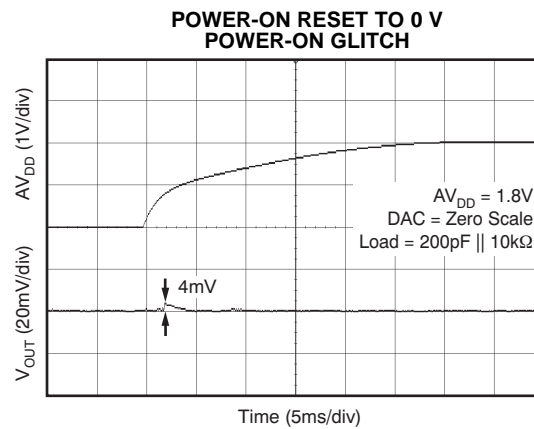


Figure 84.

TYPICAL CHARACTERISTICS: $AV_{DD} = 1.8\text{ V}$ (continued)

At $T_A = 25^\circ\text{C}$, $AV_{DD} = 1.8\text{ V}$, and DAC loaded with midscale code (unless otherwise noted)

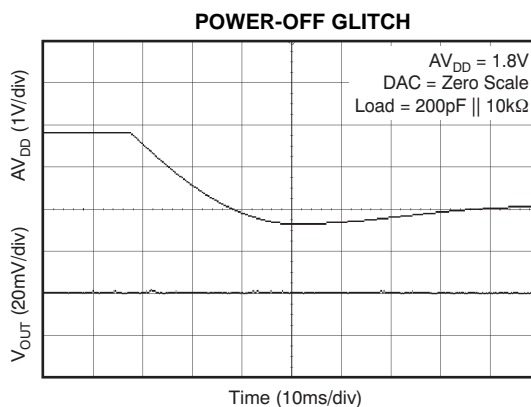


Figure 85.

THEORY OF OPERATION

DAC SECTION

The DAC5311 is fabricated using TI's proprietary HPA07 process technology. The architecture consists of a string DAC followed by an output buffer amplifier. Because there is no reference input pin, the power supply (AV_{DD}) acts as the reference. Figure 86 shows a block diagram of the DAC architecture.

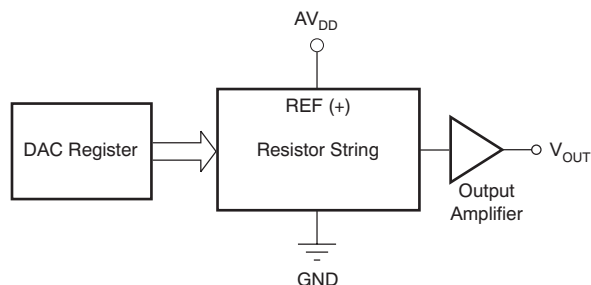


Figure 86. DAC5311 Architecture

The input coding to the DAC5311 is straight binary, so the ideal output voltage is given by:

$$V_{OUT} = AV_{DD} \times \frac{D}{2^n}$$

Where:

n = resolution in bits (8)

D = decimal equivalent of the binary code that is loaded to the DAC register. It ranges from 0 to 255 for 8-bit DAC5311.

RESISTOR STRING

The resistor string section is shown in [Figure 87](#). It is simply a string of resistors, each of value R . The code loaded into the DAC register determines at which node on the string the voltage is tapped off to be fed into the output amplifier by closing one of the switches connecting the string to the amplifier. It is tested monotonic because it is a string of resistors.

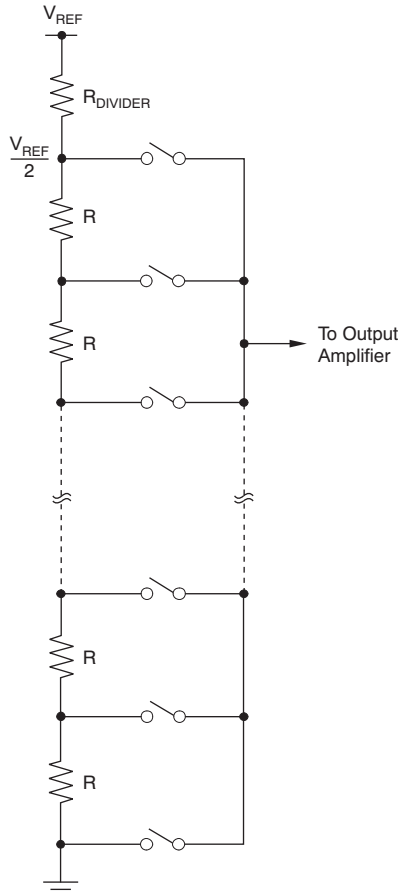


Figure 87. Resistor String

OUTPUT AMPLIFIER

The output buffer amplifier is capable of generating rail-to-rail voltages on its output which gives an output range of 0 V to AV_{DD} . It is capable of driving a load of 2 k Ω in parallel with 1000 pF to GND. The source and sink capabilities of the output amplifier can be seen in the Typical Characteristics section for the given voltage input. The slew rate is 0.7 V/ μ s with a half-scale settling time of typically 6 μ s with the output unloaded.

SERIAL INTERFACE

The DAC5311 has a 3-wire serial interface (\overline{SYNC} , SCLK, and DIN) compatible with SPI, QSPI, and Microwire interface standards, as well as most DSPs. See the [Serial Write Operation timing diagram](#) for an example of a typical write sequence.

Input Shift Register

The input shift register is 16 bits wide, as shown in [Table 2](#). The first two bits (PD0 and PD1) are reserved control bits that set the desired mode of operation (normal mode or any one of three power-down modes) as indicated in [Table 3](#).

The remaining data bits are eight data bits, followed by *don't care* bits, as shown in [Table 2](#).

The write sequence begins by bringing the $\overline{\text{SYNC}}$ line low. Data from the DIN line are clocked into the 16-bit shift register on each falling edge of SCLK. The serial clock frequency can be as high as 50 MHz, making the DAC5311 compatible with high-speed DSPs. On the 16th falling edge of the serial clock, the last data bit is clocked in and the programmed function is executed.

At this point, the $\overline{\text{SYNC}}$ line may be kept low or brought high. In either case, it must be brought high for a minimum of 20 ns before the next write sequence so that a falling edge of SYNC can initiate the next write sequence. As previously mentioned, it must be brought high again before the next write sequence.

SYNC Interrupt

In a normal write sequence, the $\overline{\text{SYNC}}$ line is kept low for at least 16 falling edges of SCLK and the DAC is updated on the 16th falling edge. However, bringing SYNC high before the 16th falling edge acts as an interrupt to the write sequence. The shift register is reset and the write sequence is seen as invalid. Neither an update of the DAC register contents nor a change in the operating mode occurs, as shown in Figure 88.

Table 2. 8-Bit Data Input Register

DB15	DB14									DB6	DB5					DB0
PD1	PD0	D7	D6	D5	D4	D3	D2	D1	D0	X	X	X	X	X	X	

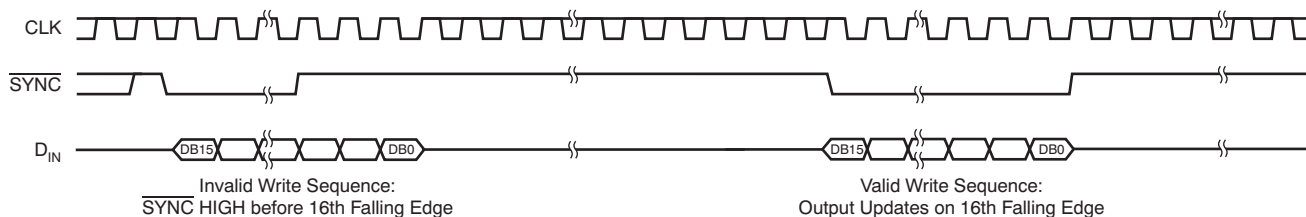


Figure 88. DAC5311 $\overline{\text{SYNC}}$ Interrupt Facility

POWER-ON RESET TO ZERO-SCALE

The DAC5311 contains a power-on reset circuit that controls the output voltage during power-up. On power-up, the DAC register is filled with zeros and the output voltage is 0 V. The DAC register remains that way until a valid write sequence is made to the DAC. This design is useful in applications where it is important to know the state of the output of the DAC while it is in the process of powering up.

The occurring power-on glitch impulse is only a few millivolts (typically, 17 mV; see Figure 25).

POWER-DOWN MODES

The DAC5311 contains four separate modes of operation. These modes are programmable by setting two bits (PD1 and PD0) in the control register. Table 3 shows how the state of the bits corresponds to the mode of operation of the device.

Table 3. Modes of Operation

PD1	PD0	OPERATING MODE
Normal Mode		
0	0	Normal Operation
Power-Down Modes		
0	1	Output 1 kΩ to GND
1	0	Output 100 kΩ to GND
1	1	High-Z

When both bits are set to '0', the device works normally with a standard power consumption of typically 80 μA at 1.8 V. However, for the three power-down modes, the typical supply current falls to 0.5 μA at 5 V, 0.4 μA at 3V, and 0.1 μA at 1.8 V. Not only does the supply current fall, but the output stage is also internally switched from the output of the amplifier to a resistor network of known values. The advantage of this architecture is that the output impedance of the part is known while the part is in power-down mode. There are three different options. The output is connected internally to GND either through a 1-k Ω resistor or a 100-k Ω resistor, or is left open-circuited (High-Z). Figure 89 illustrates the output stage.

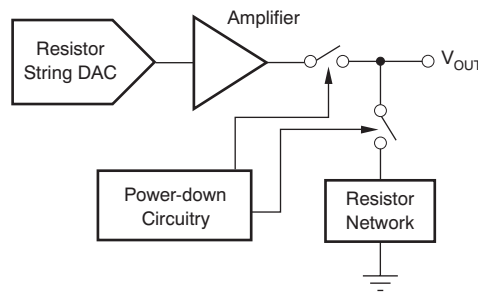


Figure 89. Output Stage During Power-Down

All linear circuitry is shut down when the power-down mode is activated. However, the contents of the DAC register are unaffected when in power-down. The time to exit power-down is typically 50 μs for $\text{AV}_{\text{DD}} = 5 \text{ V}$ and $\text{AV}_{\text{DD}} = 3 \text{ V}$.

DAC NOISE PERFORMANCE

Typical noise performance is shown in *Typical Characteristics*. Output noise spectral density at the V_{OUT} pin versus frequency is depicted for full-scale, midscale, and zero-scale input codes. The typical noise density for midscale code is 110 nV/ $\sqrt{\text{Hz}}$ at 1 kHz and at 1 MHz.

APPLICATION INFORMATION

USING THE REF5050 AS A POWER SUPPLY FOR THE DAC5311

As a result of the extremely low supply current required by the DAC5311, an alternative option is to use a REF5050 5 V precision voltage reference to supply the required voltage to the part, as shown in Figure 90. This option is especially useful if the power supply is too noisy or if the system supply voltages are at some value other than 5 V. The REF5050 outputs a steady supply voltage for the DAC5311. If the REF5050 is used, the current needed to supply DAC5311 is typically 110 μ A at 5 V, with no load on the output of the DAC. When the DAC output is loaded, the REF5050 also needs to supply the current to the load. The total current required (with a 5-k Ω load on the DAC output) is:

$$110 \mu\text{A} + (5 \text{ V}/5 \text{ k}\Omega) = 1.11 \text{ mA}$$

The load regulation of the REF5050 is typically 0.002%/mA, which results in an error of 90 μ V for the 1.1 mA current drawn from it.

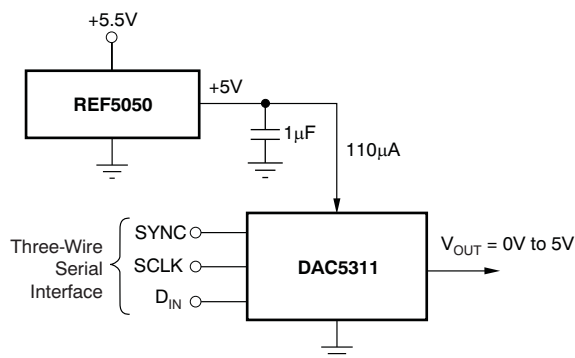


Figure 90. REF5050 as Power Supply to DAC5311

For other power-supply voltages, alternative references such as the REF3030 (3 V), REF3033 (3.3 V), or REF3220 (2.048 V) are recommended. For a full list of available voltage references from TI, see the TI web site at www.ti.com.

BIPOLAR OPERATION

The DAC5311 has been designed for single-supply operation but a bipolar output range is also possible using the circuit in Figure 91. The circuit shown gives an output voltage range of ± 5 V. Rail-to-rail operation at the amplifier output is achievable using an OPA211, OPA340, or OPA703 as the output amplifier. For a full list of available operational amplifiers from TI, see the TI web site at www.ti.com

The output voltage for any input code can be calculated as follows:

$$V_O = \left[AV_{DD} \times \left(\frac{D}{2^n} \right) \times \left(\frac{R_1 + R_2}{R_1} \right) - AV_{DD} \times \left(\frac{R_2}{R_1} \right) \right] \quad (1)$$

Where:

n = resolution in bits (8)

D = decimal equivalent of the binary code that is loaded to the DAC register. It ranges from 0 to 255 for 8-bit DAC5311.

With $AV_{DD} = 5$ V, $R_1 = R_2 = 10$ k Ω :

$$V_O = \left(\frac{10 \times D}{2^n} \right) - 5V \quad (2)$$

This is an output voltage range of ± 5 V with 00h corresponding to a -5 V output and FFh corresponding to a 5-V output.

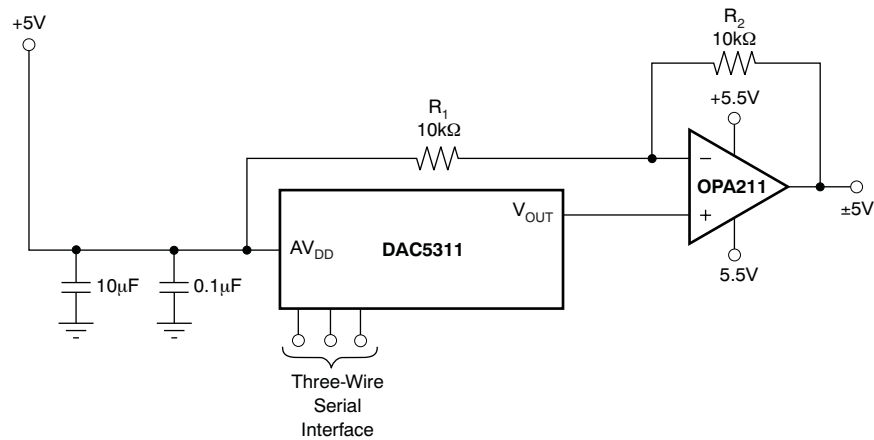
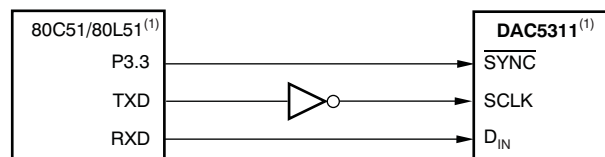


Figure 91. Bipolar Operation with the DAC5311

MICROPROCESSOR INTERFACING

DAC5311 to 8051 Interface

Figure 92 shows a serial interface between the DAC5311 and a typical 8051-type microcontroller. The setup for the interface is as follows: TXD of the 8051 drives SCLK of the DAC5311, while RXD drives the serial data line of the part. The SYNC signal is derived from a bit programmable pin on the port. In this case, port line P3.3 is used. When data are to be transmitted to the DAC5311, P3.3 is taken low. The 8051 transmits data only in 8-bit bytes; thus, only eight falling clock edges occur in the transmit cycle. To load data to the DAC, P3.3 remains low after the first eight bits are transmitted, and a second write cycle is initiated to transmit the second byte of data. P3.3 is taken high following the completion of this cycle. The 8051 outputs the serial data in a format which has the LSB first. The DAC5311 requires its data with the MSB as the first bit received. Therefore, the 8051 transmit routine must take this requirement into account, and *mirror* the data as needed.

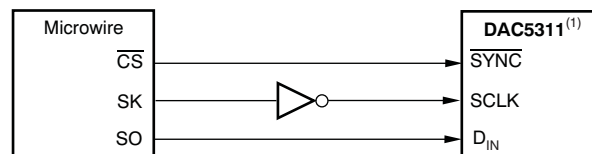


NOTE: (1) Additional pins omitted for clarity.

Figure 92. DAC5311 to 80C51/80L51 Interfaces

DAC5311 to Microwire Interface

Figure 93 shows an interface between the DAC5311 and any Microwire-compatible device. Serial data are shifted out on the falling edge of the serial clock and are clocked into the DAC5311 on the rising edge of the SK signal.

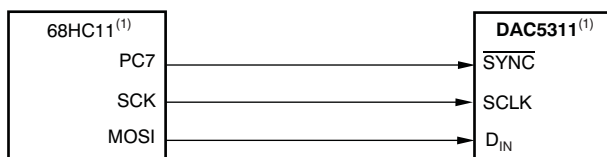


NOTE: (1) Additional pins omitted for clarity.

Figure 93. DAC5311 to Microwire Interface

DAC5311 to 68HC11 Interface

Figure 94 shows a serial interface between the DAC5311 and the 68HC11 microcontroller. SCK of the 68HC11 drives the SCLK of the DAC5311, while the MOSI output drives the serial data line of the DAC. The SYNC signal is derived from a port line (PC7), similar to what was done for the 8051.



NOTE: (1) Additional pins omitted for clarity.

Figure 94. DAC5311 to 68HC11 Interface

The 68HC11 should be configured so that its CPOL bit is a '0' and its CPHA bit is a '1'. This configuration causes data appearing on the MOSI output to be valid on the falling edge of SCK. When data are being transmitted to the DAC, the SYNC line is taken low (PC7). Serial data from the 68HC11 are transmitted in 8-bit bytes with only eight falling clock edges occurring in the transmit cycle. Data are transmitted MSB first. In order to load data to the DAC5311, PC7 is held low after the first eight bits are transferred, and a second serial write operation is performed to the DAC; PC7 is taken high at the end of this procedure.

LAYOUT

A precision analog component requires careful layout, adequate bypassing, and clean, well-regulated power supplies.

The DAC5311 offers single-supply operation; it is often used in close proximity with digital logic, microcontrollers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult it is to achieve good performance from the converter.

Because of the single ground pin of the DAC5311, all return currents, including digital and analog return currents, must flow through the GND pin. Ideally, GND is connected directly to an analog ground plane. This plane should be separate from the ground connection for the digital components until they are connected at the power entry point of the system.

The power applied to AV_{DD} should be well-regulated and low-noise. Switching power supplies and dc/dc converters often have high-frequency glitches or spikes riding on the output voltage. In addition, digital components can create similar high-frequency spikes as the internal logic switches state. This noise can easily couple into the DAC output voltage through various paths between the power connections and analog output. This condition is particularly true for the DAC5311, as the power supply is also the reference voltage for the DAC.

As with the GND connection, AV_{DD} should be connected to a 5 V power supply plane or trace that is separate from the connection for digital logic until they are connected at the power entry point. In addition, the 1 μ F to 10 μ F and 0.1 μ F bypass capacitors are strongly recommended. In some situations, additional bypassing may be required, such as a 100 μ F electrolytic capacitor or even a *Pi* filter made up of inductors and capacitors—all designed to essentially low-pass filter the 5 V supply, removing the high-frequency noise.

PARAMETER DEFINITIONS

With the increased complexity of many different specifications listed in product data sheets, this section summarizes selected specifications related to digital-to-analog converters.

STATIC PERFORMANCE

Static performance parameters are specifications such as differential nonlinearity (DNL) or integral nonlinearity (INL). These are dc specifications and provide information on the accuracy of the DAC. They are most important in applications where the signal changes slowly and accuracy is required.

Resolution

Generally, the DAC resolution can be expressed in different forms. Specifications such as IEC 60748-4 recognize the numerical, analog, and relative resolution. The numerical resolution is defined as the number of digits in the chosen numbering system necessary to express the total number of steps of the transfer characteristic, where a step represents both a digital input code and the corresponding discrete analogue output value. The most commonly-used definition of resolution provided in data sheets is the numerical resolution expressed in bits.

Least Significant Bit (LSB)

The least significant bit (LSB) is defined as the smallest value in a binary coded system. The value of the LSB can be calculated by dividing the full-scale output voltage by 2^n , where n is the resolution of the converter.

Most Significant Bit (MSB)

The most significant bit (MSB) is defined as the largest value in a binary coded system. The value of the MSB can be calculated by dividing the full-scale output voltage by 2. Its value is one-half of full-scale.

Relative Accuracy or Integral Nonlinearity (INL)

Relative accuracy or integral nonlinearity (INL) is defined as the maximum deviation between the real transfer function and a straight line passing through the endpoints of the ideal DAC transfer function. INL is measured in LSBs.

Differential Nonlinearity (DNL)

Differential nonlinearity (DNL) is defined as the maximum deviation of the real LSB step from the ideal 1 LSB step. Ideally, any two adjacent digital codes correspond to output analog voltages that are exactly one LSB apart. If the DNL is within ± 1 LSB, the DAC is said to be monotonic.

Full-Scale Error

Full-scale error is defined as the deviation of the real full-scale output voltage from the ideal output voltage while the DAC register is loaded with the full-scale code (0xFFFF). Ideally, the output should be $V_{DD} - 1$ LSB. The full-scale error is expressed in percent of full-scale range (%FSR).

Offset Error

Offset error is defined as the difference between actual output voltage and the ideal output voltage in the linear region of the transfer function. This difference is calculated by using a straight line defined by two codes (for example, for 16-bit resolution, codes 485 and 64714). Since the offset error is defined by a straight line, it can have a negative or positive value. Offset error is measured in mV.

Zero-Code Error

Zero-code error is defined as the DAC output voltage, when all '0's are loaded into the DAC register. Zero-scale error is a measure of the difference between actual output voltage and ideal output voltage (0 V). It is expressed in mV. It is primarily caused by offsets in the output amplifier.

Gain Error

Gain error is defined as the deviation in the slope of the real DAC transfer characteristic from the ideal transfer function. Gain error is expressed as a percentage of full-scale range (%FSR).

Full-Scale Error Drift

Full-scale error drift is defined as the change in full-scale error with a change in temperature. Full-scale error drift is expressed in units of %FSR/°C.

Offset Error Drift

Offset error drift is defined as the change in offset error with a change in temperature. Offset error drift is expressed in $\mu\text{V}/^\circ\text{C}$.

Zero-Code Error Drift

Zero-code error drift is defined as the change in zero-code error with a change in temperature. Zero-code error drift is expressed in $\mu\text{V}/^\circ\text{C}$.

Gain Temperature Coefficient

The gain temperature coefficient is defined as the change in gain error with changes in temperature. The gain temperature coefficient is expressed in ppm of FSR/°C.

Power-Supply Rejection Ratio (PSRR)

Power-supply rejection ratio (PSRR) is defined as the ratio of change in output voltage to a change in supply voltage for a full-scale output of the DAC. The PSRR of a device indicates how the output of the DAC is affected by changes in the supply voltage. PSRR is measured in decibels (dB).

Monotonicity

Monotonicity is defined as a slope whose sign does not change. If a DAC is monotonic, the output changes in the same direction or remains at least constant for each step increase (or decrease) in the input code.

DYNAMIC PERFORMANCE

Dynamic performance parameters are specifications such as settling time or slew rate, which are important in applications where the signal rapidly changes and/or high frequency signals are present.

Slew Rate

The output slew rate (SR) of an amplifier or other electronic circuit is defined as the maximum rate of change of the output voltage for all possible input signals.

$$\text{SR} = \max \left(\left| \frac{\Delta V_{\text{OUT}}(t)}{\Delta t} \right| \right) \quad (3)$$

Where $\Delta V_{\text{OUT}}(t)$ is the output produced by the amplifier as a function of time t .

Output Voltage Settling Time

Settling time is the total time (including slew time) for the DAC output to settle within an error band around its final value after a change in input. Settling times are specified to within $\pm 0.003\%$ (or whatever value is specified) of full-scale range (FSR).

Code Change/Digital-to-Analog Glitch Energy

Digital-to-analog glitch impulse is the impulse injected into the analog output when the input code in the DAC register changes state. It is normally specified as the area of the glitch in nanovolts-second (nV-s), and is measured when the digital input code is changed by 1 LSB at the major carry transition.

Digital Feed Through

Digital feed through is defined as impulse seen at the output of the DAC from the digital inputs of the DAC. It is measured when the DAC output is not updated. It is specified in nV-s, and measured with a full-scale code change on the data bus; that is, from all '0's to all '1's and vice versa.

Channel-to-Channel DC Crosstalk

Channel-to-channel dc crosstalk is defined as the dc change in the output level of one DAC channel in response to a change in the output of another DAC channel. It is measured with a full-scale output change on one DAC channel while monitoring another DAC channel remains at midscale. It is expressed in LSB.

Channel-to-Channel AC Crosstalk

AC crosstalk in a multi-channel DAC is defined as the amount of ac interference experienced on the output of a channel at a frequency (f) (and its harmonics), when the output of an adjacent channel changes its value at the rate of frequency (f). It is measured with one channel output oscillating with a sine wave of 1-kHz frequency, while monitoring the amplitude of 1-kHz harmonics on an adjacent DAC channel output (kept at zero scale). It is expressed in dB.

Signal-to-Noise Ratio (SNR)

Signal-to-noise ratio (SNR) is defined as the ratio of the root mean-squared (RMS) value of the output signal divided by the RMS values of the sum of all other spectral components below one-half the output frequency, not including harmonics or dc. SNR is measured in dB.

Total Harmonic Distortion (THD)

Total harmonic distortion + noise is defined as the ratio of the RMS values of the harmonics and noise to the value of the fundamental frequency. It is expressed in a percentage of the fundamental frequency amplitude at sampling rate f_s .

Spurious-Free Dynamic Range (SFDR)

Spurious-free dynamic range (SFDR) is the usable dynamic range of a DAC before spurious noise interferes or distorts the fundamental signal. SFDR is the measure of the difference in amplitude between the fundamental and the largest harmonically or non-harmonically related spur from dc to the full Nyquist bandwidth (half the DAC sampling rate, or $f_s/2$). A spur is any frequency bin on a spectrum analyzer, or from a Fourier transform, of the analog output of the DAC. SFDR is specified in decibels relative to the carrier (dBc).

Signal-to-Noise Plus Distortion (SINAD)

SINAD includes all the harmonic and outstanding spurious components in the definition of output noise power in addition to quantizing any internal random noise power. SINAD is expressed in dB at a specified input frequency and sampling rate, f_s .

DAC Output Noise Density

Output noise density is defined as internally-generated random noise. Random noise is characterized as a spectral density (nV/\sqrt{Hz}). It is measured by loading the DAC to midscale and measuring noise at the output.

DAC Output Noise

DAC output noise is defined as any voltage deviation of DAC output from the desired value (within a particular frequency band). It is measured with a DAC channel kept at midscale while filtering the output voltage within a band of 0.1 Hz to 10 Hz and measuring its amplitude peaks. It is expressed in terms of peak-to-peak voltage (V_{pp}).

Full-Scale Range (FSR)

Full-scale range (FSR) is the difference between the maximum and minimum analog output values that the DAC is specified to provide; typically, the maximum and minimum values are also specified. For an n -bit DAC, these values are usually given as the values matching with code 0 and $2^n - 1$.

TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DAC5311IDCKRQ1	SC70	DCK	6	3000	177.8	9.7	2.3	2.52	1.2	4.0	8.0	Q3

TAPE AND REEL BOX DIMENSIONS

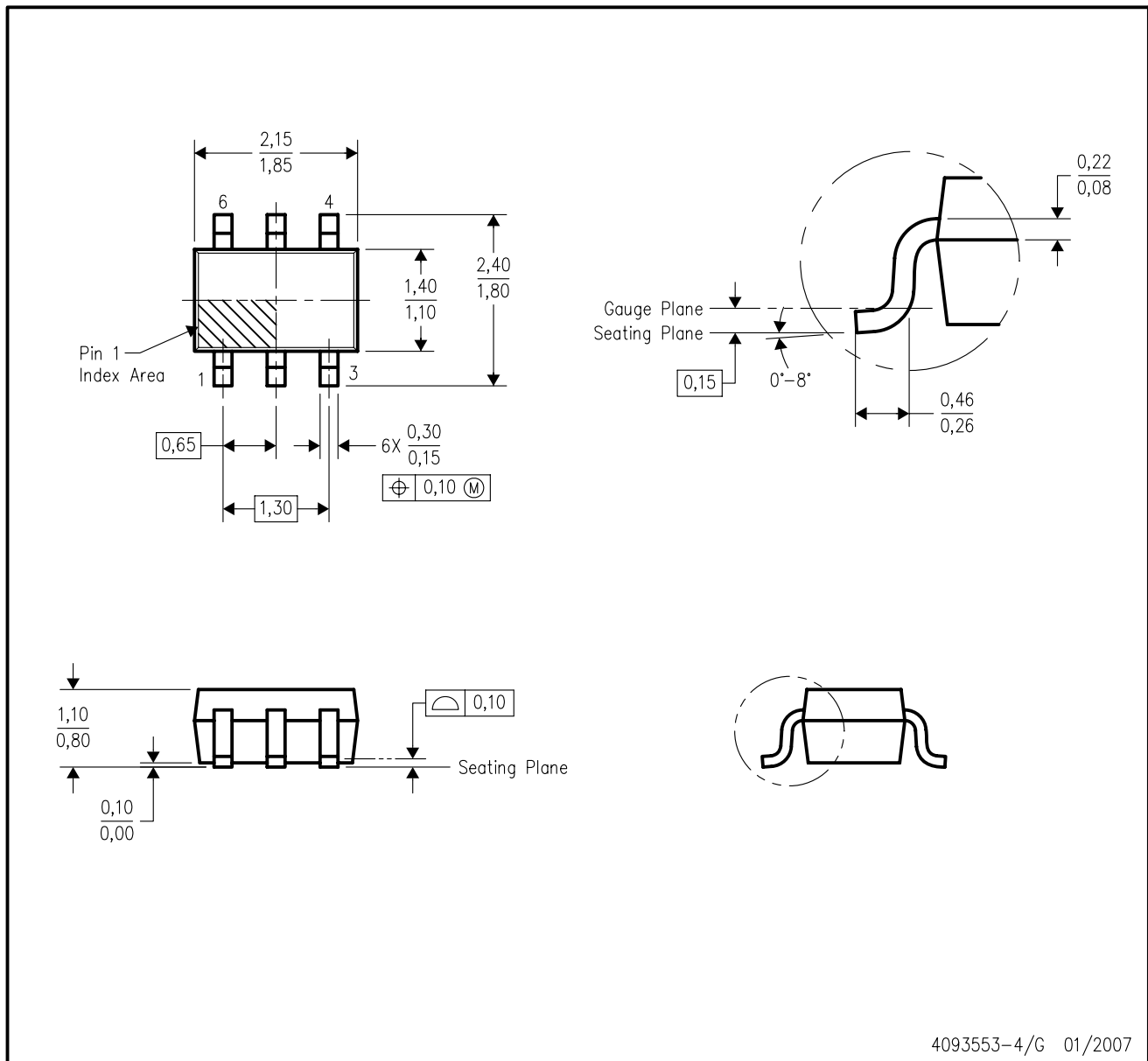


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DAC5311IDCKRQ1	SC70	DCK	6	3000	184.0	184.0	50.0

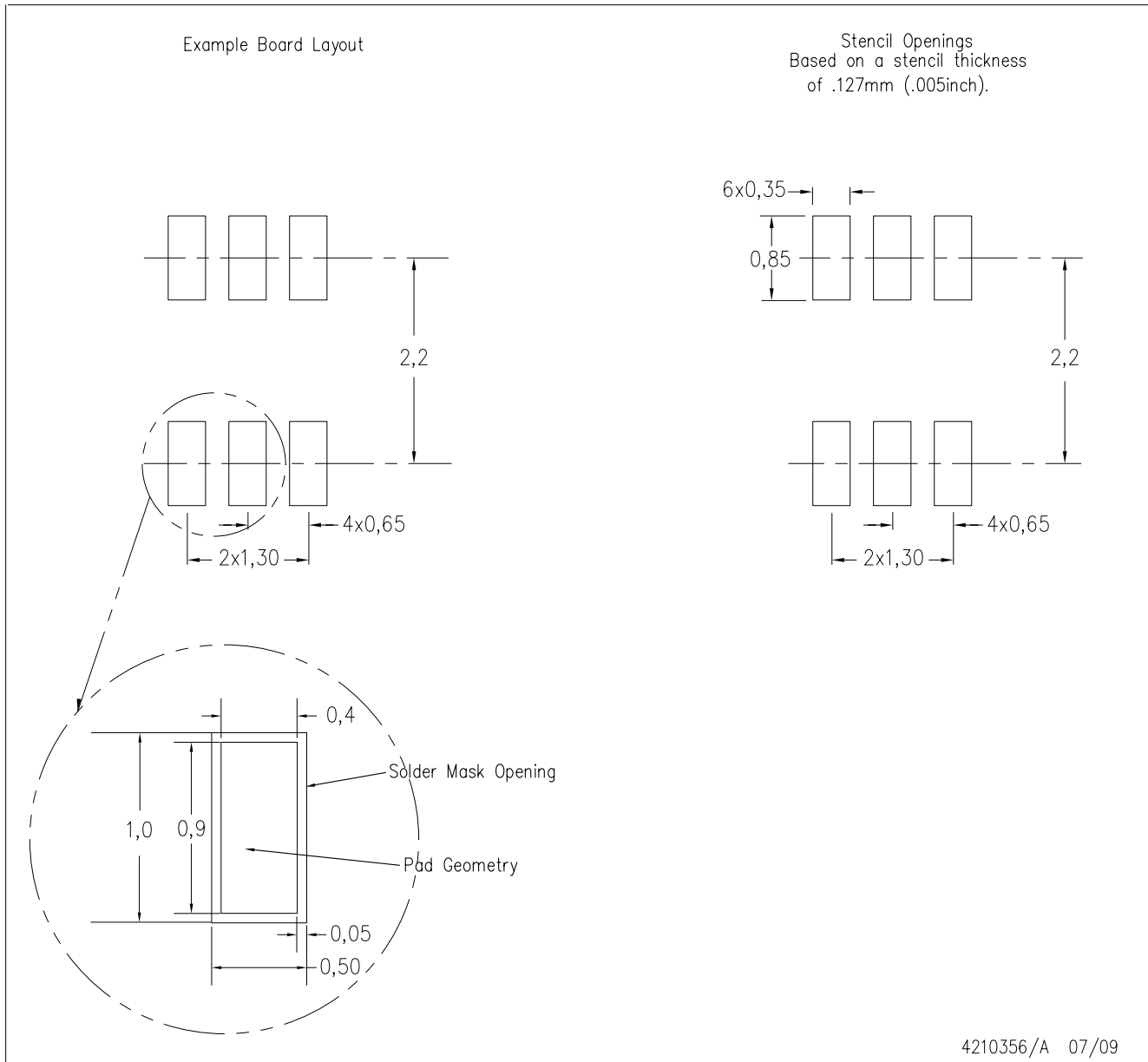
DCK (R-PDSO-G6)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
 - D. Falls within JEDEC MO-203 variation AB.

DCK (R-PDSO-G6)



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
 - Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.

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